

TH25Q-16UB

Ultra Low Power, 16M-bit

Serial Multi I/O Flash Memory Datasheet

Mar.18, 2022

Performance Highlight

- Wide Supply Range from 1.65 to 3.6V for Read, Erase and Program
- Ultra Low Power consumption for Read, Erase and Program
- X1, X2 and X4 Multi I/O Support
- High reliability with 100K cycling and 20 Year-retention



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1. FEATURES

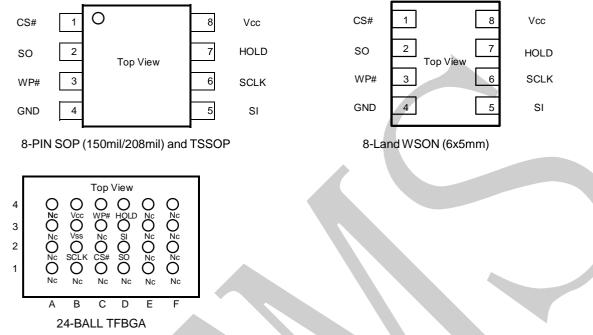
- 16M-bit Serial Flash
 -2048K-Byte
 -256 Bytes per programmable page
- Standard, Dual, Quad SPI
 Standard SPI: SCLK, CS#, SI, SO, WP#, HOLD#
 Dual SPI: SCLK, CS#, IO0, IO1, WP#, HOLD#
 Quad SPI: SCLK, CS#, IO0, IO1, IO2, IO3
- High Speed Clock Frequency
 -104MHz for fast read with 30PF load
 -Dual I/O Data transfer up to 208Mbits/s
 -Quad I/O Data transfer up to 416Mbits/s
- Software/Hardware Write Protection
 -Write protect all/portion of memory via software
 -Enable/Disable protection with WP# Pin
 -Top/Bottom Block protection
- Minimum 100,000 Program/Erase Cycles
- Data Retention
 -20-year data retention typical
- ◆ Allows XIP (execute in place) Operation
 - -Continuous Read With 8/16/32/64-Byte Wrap

- Fast Program/Erase Speed
 -Page Program time: 1.4ms typical
 -Sector Erase time: 5.1ms typical
 -Block Erase time: 5.1ms typical
 -Chip Erase time: 5.2ms typical
- Flexible Architecture
 -Uniform Sector of 4K-Byte
 -Uniform Block of 32/64K-Byte
- Low Power Consumption
 -0.65uA typical deep power down current
 -10uA typical standby current
- Advanced Security Features
 -128-Bit Unique ID for each device
 -4x256-Byte security registers with OTP locks
 -Discoverable parameters (SFDP) register
- Single Power Supply Voltage
 Full voltage range:1.65~3.6V
- Package Information
 -SOP8 (150mil)
 -SOP8 (208mil)
 -TSSOP8 (173mil)
 -USON8 (3*2mm)
 -WSON8 (6*5mm)
 -TFBGA-24(6*4 ball array)

2. GENERAL DESCRIPTION

The TH25Q-16UB(16M-bit) Serial flash supports the standard Serial Peripheral Interface (SPI), and supports the Dual/Quad SPI: Serial Clock, Chip Select, Serial Data I/O0 (SI), I/O1 (SO), I/O2 (WP#), and I/O3 (HOLD#). The Dual I/O data is transferred with speed of 208Mbits/s and the Quad I/O & Quad output data is transferred with speed of 416Mbits/s.

CONNECTION DIAGRAM



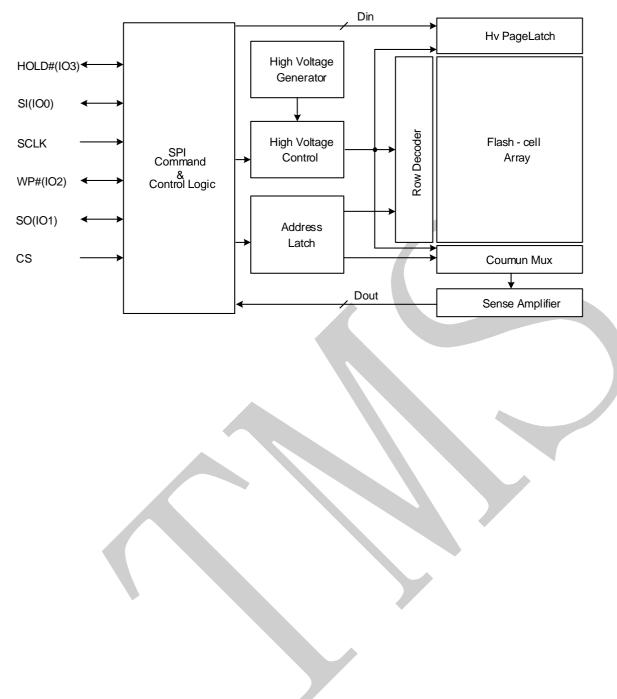
PIN DESCRIPTION

Pin Name	1/0	Description		
CS#	1	Chip Select Input		
SO (IO1)	I/O	Data Output (Data Input Output 1)		
WP# (IO2)	I/O	Write Protect Input (Data Input Output 2)		
GND		Ground		
SI (IO0)	I/O	Data Input (Data Input Output 0)		
SCLK	I	Serial Clock Input		
HOLD# (IO3)	I/O	Hold Input (Data Input Output 3)		
VCC		Power Supply		

Note: CS# must be driven high if chip is not selected. Please don't leave CS# floating any time after power is on.



BLOCK DIAGRAM



3. MEMORY ORGANIZATION

TH25Q-16UB

Each device has	Each block has	Each sector has	Each page has	
2M	64/32K	4К	256	Bytes
8К	256/128	16	-	pages
512	16/8	-	-	sectors
32/64	-	-	-	blocks

UNIFORM BLOCK SECTOR ARCHITECTURE TH25Q-16UB 64K Bytes Block Sector Architecture

Block	Sector	Addres	s range
	511	1FF000H	1FFFFFH
31	•••••		
	496	1F0000H	1F0FFFH
	495	1EF000H	1EFFFFH
30			
	480	1E0000H	1EOFFFH
			•••••
	47	02F000H	02FFFFH
2			•••
	32	020000H	020FFFH
	31	01F000H	01FFFFH
1			
	16	010000H	010FFFH
	15	00F000H	00FFFFH
0		•••••	
	0	000000H	000FFFH

4. DEVICE OPERATION

SPI Mode Standard SPI

The TH25Q-16UB features a serial peripheral interface on 4 signals bus: Serial Clock (SCLK), Chip Select (CS#), Serial Data Input (SI) and Serial Data Output (SO). Both SPI bus mode 0 and 3 are supported. Input data is latched on the rising edge of SCLK and data shifts out on the falling edge of SCLK.

Dual SPI

The TH25Q-16UB supports Dual SPI operation when using the "Dual Output Fast Read" and "Dual I/O Fast Read" (3BH and BBH) commands. These commands allow data to be transferred to or from the device at twice the rate of the standard SPI. When using the Dual SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1.

Quad SPI

The TH25Q-16UB supports Quad SPI operation when using the "Quad Output Fast Read" (6BH), "Quad I/O Fast Read" (EBH), "Quad I/O Word Fast Read" (E7H) and "Quad Page Program" (32H) commands. These commands allow data to be transferred to or from the device at four times the rate of the standard SPI. When using the Quad SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1, and WP# and HOLD# pins become IO2 and IO3. Quad SPI commands require the non-volatile Quad Enable bit (QE) in Status Register to be set.

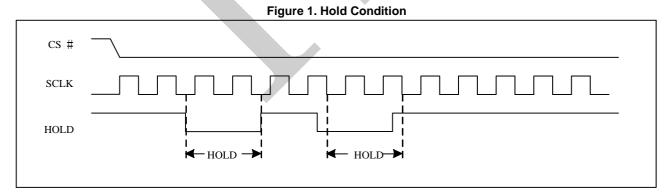
Hold

The HOLD# function is only available when QE=0, If QE=1, The HOLD# functions is disabled, the pin acts as dedicated data I/O pin.

The HOLD# signal goes low to stop any serial communications with the device, but doesn't stop the operation of write status register, programming, or erasing in progress.

The operation of HOLD, need CS# keep low, and starts on falling edge of the HOLD# signal, with SCLK signal being low (if SCLK is not being low, HOLD operation will not start until SCLK being low). The HOLD condition ends on rising edge of HOLD# signal with SCLK being low (If SCLK is not being low, HOLD operation will not end until SCLK being low).

The SO is high impedance, both SI and SCLK don't care during the HOLD operation, if CS# drives high during HOLD operation, it will reset the internal logic of the device. To re-start communication with chip, the HOLD# must be at high and then CS# must be at low.



5. DATA PROTECTION

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The TH25Q-16UB provide the following data protection methods:

Write Enable (WREN) command: The WREN command is set the Write Enable Latch bit (WEL). The WEL bit will
return to reset by the following situation:

-Power-Up

-Write Disable (WRDI)

-Write Status Register (WRSR)

-Page Program (PP)

-Sector Erase (SE) / Block Erase (BE) / Chip Erase (CE)

- Software Protection Mode: The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.
- Hardware Protection Mode: WP# goes low to protect the BP0~BP4 bits and SRP0~1 bits.
- Deep Power-Down Mode: In Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down Mode command.

	Status Re	gister Co	ntent		Memory Content				
BP4	BP4 BP3 BP2 BP1 BP0				Blocks	Addresses	Density	Portion	
Х	Х	0	0	0	NONE	NONE	NONE	NONE	
0	0	0	0	1	31	1F0000H-1FFFFFH	64KB	Upper 1/32	
0	0	0	1	0	30 to 31	1E0000H-1FFFFFH	128КВ	Upper 1/16	
0	0	0	1	1	28 to 31	1C0000H-1FFFFFH	256KB	Upper 1/8	
0	0	1	0	0	24 to 31	180000H-1FFFFFH	512KB	Upper 1/4	
0	0	1	0	1	16 to 31	100000H-1FFFFFH	1M	Upper 1/2	
0	1	0	0	1	0	000000H-00FFFFH	64KB	Lower 1/32	
0	1	0	1	0	0 to 1	000000H-01FFFFH	128KB	Lower 1/16	
0	1	0	1	1	0 to 3	000000H-03FFFFH	256KB	Lower 1/8	
0	1	1	0	0	0 to 7	000000H-07FFFFH	512KB	Lower 1/4	
0	1	1	0	1	0 to 15	000000H-0FFFFFH	1M	Lower 1/2	
Х	Х	1	1	х	0 to 31	000000H-1FFFFFH	2M	ALL	
1	0	0	0	1	31	1FF000H-1FFFFFH	4KB	Top Block	
1	0	0	1	0	31	1FE000H-1FFFFFH	8KB	Top Block	
1	0	0	1	1	31	1FC000H-1FFFFFH	16KB	Top Block	
1	0	1	0	Х	31	1F8000H-1FFFFFH	32KB	Top Block	
1	1	0	0	1	0	000000H-000FFFH	4KB	Bottom Block	
1	1	0	1	0	0	000000H-001FFFH	8KB	Bottom Block	
1	1	0	1	1	0	000000H-003FFFH	16KB	Bottom Block	
1	1	1	0	Х	0	000000H-007FFFH	32KB	Bottom Block	

Table1.0 TH25Q-16UB Protected area size (CMP=0)

9	Status Re	gister Co	ontent		Memory Content					
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion		
Х	Х	0	0	0	0 to 31	000000H-1FFFFFH	2M	ALL		
0	0	0	0	1	0 to 30	000000H-1EFFFFH	1984KB	Lower 31/32		
0	0	0	1	0	0 to 29	000000H-1DFFFFH	1920KB	Lower 15/16		
0	0	0	1	1	0 to 27	000000H-1BFFFFH	1792KB	Lower 7/8		
0	0	1	0	0	0 to 23	000000H-17FFFFH	1536KB	Lower 3/4		
0	0	1	0	1	0 to 15	000000H-0FFFFH	1M	Lower 1/2		
0	1	0	0	1	1 to 31	010000H-1FFFFFH	1984KB	Upper 31/32		
0	1	0	1	0	2 to 31	020000H-1FFFFFH	1920KB	Upper 15/16		
0	1	0	1	1	4 to 31	040000H-1FFFFFH	1792KB	Upper 7/8		
0	1	1	0	0	8 to 31	080000H-1FFFFFH	1536KB	Upper 3/4		
0	1	1	0	1	16 to 31	100000H-1FFFFFH	1M	Upper 1/2		
Х	Х	1	1	Х	NONE	NONE	NONE	NONE		
1	0	0	0	1	0 to 31	000000H-1FEFFFH	2044KB	Lower 511/512		
1	0	0	1	0	0 to 31	000000H-1FDFFFH	2040KB	Lower 255/256		
1	0	0	1	1	0 to 31	000000H-1FBFFFH	2032KB	Lower 127/128		
1	0	1	0	Х	0 to 31	000000H-1F7FFFH	2016KB	Lower 63/64		
1	1	0	0	1	0 to 31	001000H-1FFFFFH	2044KB	Upper 511/512		
1	1	0	1	0	0 to 31	002000H-1FFFFFH	2040KB	Upper 255/256		
1	1	0	1	1	0 to 31	004000H-1FFFFFH	2032КВ	Upper 127/128		
1	1	1	0	х	0 to 31	008000H-1FFFFFH	2016KB	Upper 63/64		

Table1.1 TH25Q-16UB Protected area size (CMP=1)

6. STATUS REGISTER

S15	\$14	S13	\$12	\$11	S10	S9	S8
SUS	СМР	Reserved	Reserved	Reserved	LB	QE	SRP1
S7	S6	S5	S4	S3	S2	S1	S0
SRP0	BP4	BP3	BP2	BP1	BP0	WEL	WIP

The status and control bits of the Status Register are as follows:

WIP bit.

The Write in Progress (WIP) bit indicates whether the memory is busy in program/erase/write status register progress. When WIP bit sets to 1, means the device is busy in program/erase/write status register progress, when WIP bit sets 0, means the device is not in program/erase/write status register progress.

WEL bit.

The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase command is accepted.

BP4, BP3, BP2, BP1, BP0 bits.

The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase commands. These bits are written with the Write Status Register (WRSR) command. When the Block Protect (BP4, BP3, BP2, BP1, BP0) bits are set to 1, the relevant memory area (as defined in Table1).becomes protected against Page Program (PP), Sector Erase (SE) and Block Erase (BE) commands. The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) command is executed, if the Block Protect (BP2, BP1, and BP0) bits are 0 and CMP=0 or the Block Protect (BP2, BP1, and BP0) bits are 1 and CMP=1.

SRP1, SRP0 bits.

The Status Register Protect (SRP1 and SRP0) bits are non-volatile Read/Write bits in the status register. The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down or one time programmable protection.

SRP1	SRPO	#WP	Status Register	Description
0	0	х	Software Protected	The Status Register can be written to after a Write Enable command, WEL=1.(Default)
0	1	0	Hardware Protected	WP#=0, the Status Register locked and cannot be written to.
0	1	1	Hardware Unprotected	WP#=1, the Status Register is unlocked and can be written to after a Write Enable command, WEL=1.
1	0	х	Power Supply Lock-Down ⁽¹⁾ (2)	Status Register is protected and cannot be written to again until the next Power-Down, Power-Up cycle.
1	1	х	One Time Program ⁽²⁾	Status Register is permanently protected and cannot be written to.

NOTE:

1. When SRP1, SRP0= (1, 0), a Power-Down, Power-Up cycle will change SRP1, SRP0 to (0, 0) state.

2. This feature is available on special order. Please contact TMS Device for details.

QE bit.

The Quad Enable (QE) bit is a non-volatile Read/Write bit in the Status Register that allows Quad operation. When the QE bit is set to 0 (Default) the WP# pin and HOLD# pin are enable. When the QE pin is set to 1, the Quad IO2 and IO3 pins are enabled. (It is best to set the QE bit to 0 to avoid short issues if the WP# or HOLD# pin is tied directly to the power supply or ground).

LB bit.

The LB bit is a non-volatile One Time Program (OTP) bit in Status Register (S10) that provide the write protect control and status to the Security Registers. The default state of LB is 0, the security registers are unlocked. LB can be set to 1 individually using the Write Register instruction. LB is One Time Programmable, once it's set to 1, the Security Registers will become read-only permanently.

CMP bit

The CMP bit is a non-volatile Read/Write bit in the Status Register (S14). It is used in conjunction with the BP4-BP0 bits to provide more flexibility for the array protection. Please see the Status registers Memory Protection table for details. The default setting is CMP=0.

SUS bit

The SUS bit is a read only bit in the status register (S15) that is set to 1 after executing an Erase/Program Suspend (75H) command. The SUS bit is cleared to 0 by Erase/Program Resume (7AH) command as well as a power-down, power-up cycle.

7. COMMANDS DESCRIPTION

All commands, addresses and data are shifted in and out of the device, beginning with the most significant bit on the first rising edge of SCLK after CS# is driven low. Then, the one-Byte command code must be shifted in to the device, with most significant bit first on SI, and each bit is latched on the rising edges of SCLK.

See Table2, every command sequence starts with a one-Byte command code. Depending on the command, this might be followed by address Bytes, or by data Bytes, or by both or none. CS# must be driven high after the last bit of the command sequence has been completed. For the commands of Read, Fast Read, Read Status Register or Release from Deep Power-Down, and Read Device ID, the shifted-in command sequence is followed by a data-out sequence. All read instruction can be completed after any bit of the data-out sequence is being shifted out, and then CS# must be driven high to return to deselected status.

For the commands of Page Program, Sector Erase, Block Erase, Chip Erase, Write Status Register, Write Enable, Write Disable or Deep Power-Down command, CS# must be driven high exactly at a Byte boundary, otherwise the command is rejected, and is not executed. That means CS# must be driven high when the number of clock pulses after CS# being driven low is an exact multiple of eight. For Page Program, if CS# is driven high at any time the input Byte is not a full Byte, nothing will happen and WEL will not be reset.

Table2. Commands (Standard/Dual/Quad SPI)								
Command Name	Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6	n-Bytes	
Write Enable	06H							
Write Disable	04H							
Volatile SR	50H				4			
Write Enable								
Read Status Register	05H	(\$7-\$0)					(continuous)	
Read Status Register-1	35H	(S15-S8)					(continuous)	
Write Status Register	01H	S7-S0	S15-S8					
Read Data	03H	A23-A16	A15-A8	A7-A0	(D7-D0)	(Next Byte)	(continuous)	
Fast Read	OBH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(continuous)	
Dual Output	3BH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0) ⁽¹⁾	(continuous)	
Fast Read					· ·			
Dual I/O	BBH	A23-A8 ⁽²⁾	A7-A0	(D7-D0) ⁽¹⁾			(continuous)	
Fast Read			M7-M0 ⁽²⁾					
Quad Output	6BH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0) ⁽³⁾	(continuous)	
Fast Read							· ,	
Quad I/O	EBH	A23-A0	dummy ⁽⁵⁾	(D7-D0) ⁽³⁾			(continuous)	
Fast Read		M7-M0 ⁽⁴⁾	,	. ,			· ,	
Quad I/O Word	E7H	A23-A0	dummy ⁽⁶⁾	(D7-D0) ⁽³⁾			(continuous)	
Fast Read ⁽⁷⁾		M7-M0 ⁽⁴⁾		, ,			,	
Continuous Read Mode	FFH							
Reset								
Page Program	02H	A23-A16	A15-A8	A7-A0	D7-D0	Next Byte		
Dual Input Page Program	A2H	A23-A16	A15-A8	A7-A0	D7-D0			
Quad Page Program	32H	A23-A16	A15-A8	A7-A0	D7-D0			
Sector Erase	20H	A23-A16	A15-A8	A7-A0				
Block Erase(32K)	52H	A23-A16	A15-A8	A7-A0				
Block Erase(64K)	D8H	A23-A16	A15-A8	A7-A0				
Chip Erase	C7/60							
	н							
Enable Reset	66H							
Reset	99H							
Program/Erase	75/B0H							
Suspend								

Table2. Commands (Standard/Dual/Quad SPI)



Program/Erase Resume	7A/30H						
Deep Power-Down	B9H						
Release From Deep Power-Down, And Read Device ID	ABH	dummy	dummy	dummy	(DID7- DID0)		(continuous)
Release From Deep Power-Down	ABH						
Manufacturer/ Device ID	90H	dummy	dummy	00H	(MID7- MID0)	(DID7- DID0)	(continuous)
Manufacturer/ Device ID by Dual I/O	92H	A23-A8	A7-A0, M7-M0	(MID7- MID0) (DID7- DID0)			(continuous)
Quad Manufacturer/ Device ID by Quad I/O	94H	A23-A0 M7-M0	Dummy ⁽⁹⁾ (MID7- MID0) (DID7- DID0)				(continuous)
Read Unique ID	4BH	dummy	dummy	dummy	dummy	(UID7- UID0)	(continuous)
Set burst length	77H	dummy ⁽¹⁰⁾ M7-M0					
Read Serial Flash Discoverable Parameter	5AH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(continuous)
Read Identification	9FH	(MID7- M0)	(JDID15- JDID8)	(JDID7- JDID0)			(continuous)
Erase Security Registers ⁽⁸⁾	44H	A23-A16	A15-A8	A7-A0			
Program Security Registers ⁽⁸⁾	42H	A23-A16	A15-A8	A7-A0	D7-D0	D7-D0	
Read Security Registers ⁽⁸⁾	48H	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	

NOTE:

1. Dual Output data

IO0 = (D6, D4, D2, D0) IO1 = (D7, D5, D3, D1)

2. Dual Input Address

IO0 = A22, A20, A18, A16, A14, A12, A10, A8 A6, A4, A2, A0, M6, M4, M2, M0

IO1 = A23, A21, A19, A17, A15, A13, A11, A9 A7, A5, A3, A1, M7, M5, M3, M1

- 3. Quad Output Data
 - IO0 = (D4, D0,)
 - IO1 = (D5, D1,)
 - IO2 = (D6, D2,)
 - IO3 = (D7, D3,)
- 4. Quad Input Address

IO0 = A20, A16, A12, A8, A4, A0, M4, M0

- IO1 = A21, A17, A13, A9, A5, A1, M5, M1
- IO2 = A22, A18, A14, A10, A6, A2, M6, M2

IO3 = A23, A19, A15, A11, A7, A3, M7, M3

- 5. Fast Read Quad I/O Data
 - IO0 = (x, x, x, x, D4, D0,...)
 - IO1 = (x, x, x, x, D5, D1,...)
 - IO2 = (x, x, x, x, D6, D2,...)
 - IO3 = (x, x, x, x, D7, D3,...)
- 6. Fast Word Read Quad I/O Data
 - IO0 = (x, x, D4, D0,...)
 - IO1 = (x, x, D5, D1,...)
 - IO2 = (x, x, D6, D2,...)
 - IO3 = (x, x, D7, D3,...)
- 7. Fast Word Read Quad I/O Data: the lowest address bit must be 0.
- 8. Security Registers Address:

Security Register0: A23-A16=00H, A15-A8=00H, A7-A0= Byte Address; Security Register1: A23-A16=00H, A15-A8=01H, A7-A0= Byte Address; Security Register2: A23-A16=00H, A15-A8=02H, A7-A0= Byte Address; Security Register3: A23-A16=00H, A15-A8=03H, A7-A0= Byte Address.

- 9. Address, Continuous Read Mode bits, Dummy bits, Manufacture ID and Device ID
 - IO0 = (A20, A16, A12, A8, A4, A0, M4, M0, x, x, x, x, MID4, MID0, DID4, DID0, ...)
 - IO1 = (A21, A17, A13, A9, A5, A1, M5, M1, x, x, x, x, MID5, MID1, DID5, DID1, ...)
 - IO2 = (A22, A18, A14, A10, A6, A2, M6, M2, x, x, x, x, MID6, MID2, DID6, DID2, ...)
 - IO3 = (A23, A19, A15, A11, A7, A3, M7, M3, x, x, x, x, MID7, MID3, DID7, DID3, ...)
- 10. Dummy bits and Wrap Bits

IO0 = (x, x, x, x, x, x, W4,x) IO1 = (x, x, x, x, x, x, W5, x) IO2 = (x, x, x, x, x, x, W6, x) IO3 = (x, x, x, x, x, x, x, x, x)

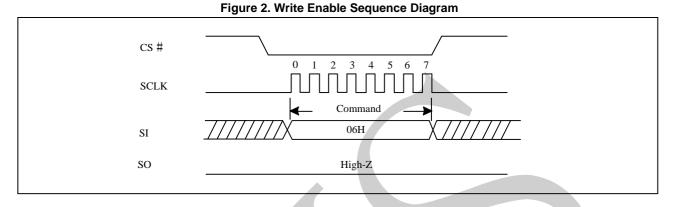
Table of ID Definitions:

TH25Q-16UB

Operation Code	MID7-MID0	ID15-ID8	ID7-ID0
9FH	EB	70	15
90H	EB		14
ABH			14

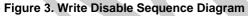
7.1. Write Enable (WREN) (06H)

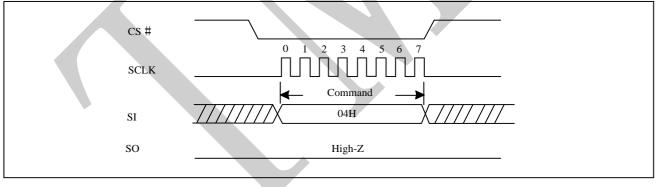
The Write Enable (WREN) command is for setting the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to every Page Program (PP), Sector Erase (SE), Block Erase (BE), Chip Erase (CE), Write Status Register (WRSR) and Erase/Program Security Registers command. The Write Enable (WREN) command sequence: CS# goes low sending the Write Enable command CS# goes high.



7.2. Write Disable (WRDI) (04H)

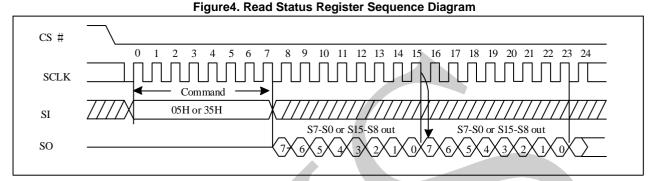
The Write Disable command is for resetting the Write Enable Latch (WEL) bit. The Write Disable command sequence: CS# goes low Sending the Write Disable command CS# goes high. The WEL bit is reset by following condition: Power- up and upon completion of the Write Status Register, Page Program, Sector Erase, Block Erase, Chip Erase, Erase/Program Security Registers and Reset commands.





7.3. Read Status Register (RDSR) (05H or 35H)

The Read Status Register (RDSR) command is for reading the Status Register. The Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new command to the device. It is also possible to read the Status Register continuously. For command code "05H", the SO will output Status Register bits S7~S0. The command code "35H", the SO will output Status Register bits S15~S8.

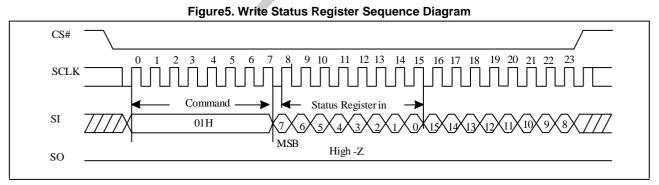


7.4. Write Status Register (WRSR) (01H)

The Write Status Register (WRSR) command allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

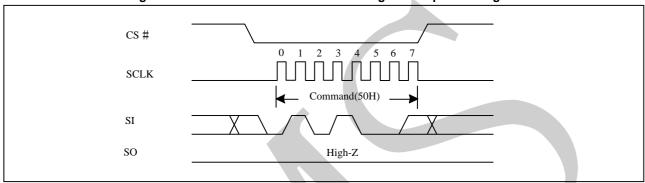
The Write Status Register (WRSR) command has no effect on S15, S1 and S0 of the Status Register. CS# must be driven high after the sixteen bit of the data Byte has been latched in. If not, the Write Status Register (WRSR) command is not executed correctly. As soon as CS# is driven high, the self-timed Write Status Register cycle (whose duration is tW) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) command allows the user to change the values of the Block Protect (BP4, BP3, BP2, BP1, BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Table1. The Write Status Register (WRSR) command also allows the user to set or reset the Status Register Protect (SRP) bit in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP) bit and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode. The Write Status Register (WRSR) command is not executed once the Hardware Protected Mode is entered.



7.5. Write Enable for Volatile Status Register (50H)

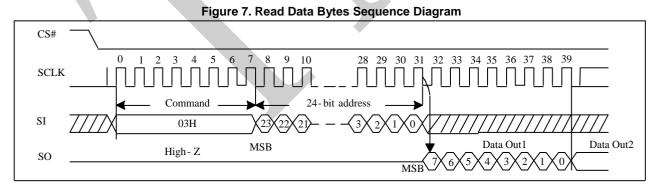
The non-volatile Status Register bits can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status Register command and any other commands can't be inserted between them. Otherwise, Write Enable for Volatile Status Register will be cleared. The Write Enable for Volatile Status Register command will not set the Write Enable Latch bit, it is only valid for the Write Status Register command to change the volatile Status Register bit values.





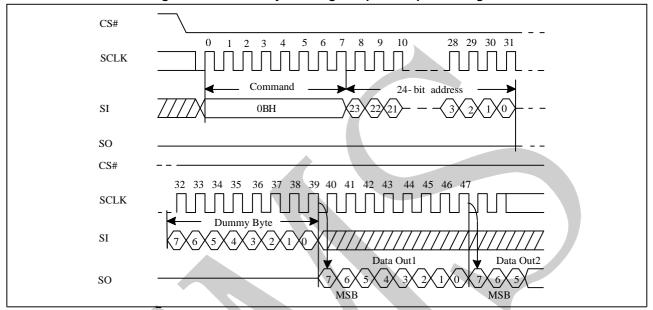
7.6. Read Data Bytes (READ) (03H)

The Read Data Bytes (READ) command is followed by a 3-Byte address (A23-A0), and each bit is latched-in on the rising edge of SCLK. Then the memory content at that address is shifted out on SO, and each bit is shifted out at a Max frequency fR on the falling edge of SCLK. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) command. Any Read Data Bytes (READ) command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



7.7. Read Data Bytes at Higher Speed (Fast Read) (0BH)

The Read Data Bytes at Higher Speed (Fast Read) command is for quickly reading data out. It is followed by a 3- Byte address (A23-A0) and a dummy Byte, and each bit is latched-in on the rising edge of SCLK. Then the memory content at that address is shifted out on SO, and each bit is shifted out at a Max frequency fC, on the falling edge of SCLK. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.





7.8. Dual Output Fast Read (3BH)

The Dual Output Fast Read command is followed by 3-Byte address (A23-A0) and a dummy Byte, each bit being latched in during the rising edge of SCLK, then the memory contents are shifted out 2-bit per clock cycle from SI and SO. The command sequence is shown in followed Figure 9 The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

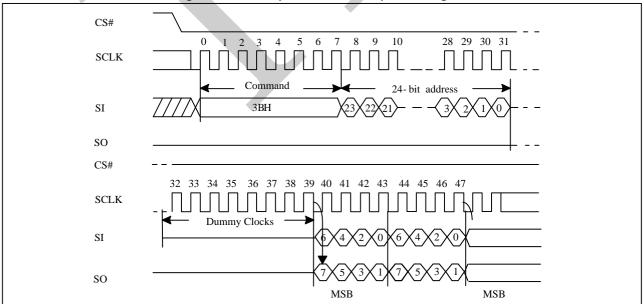


Figure 9. Dual Output Fast Read Sequence Diagram

7.9. Quad Output Fast Read (6BH)

The Quad Output Fast Read command is followed by 3-Byte address (A23-A0) and a dummy Byte, each bit being latched in during the rising edge of SCLK, then the memory contents are shifted out 4-bit per clock cycle from IO3, IO2, IO1 and IO0. The command sequence is shown in followed Figure 10. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

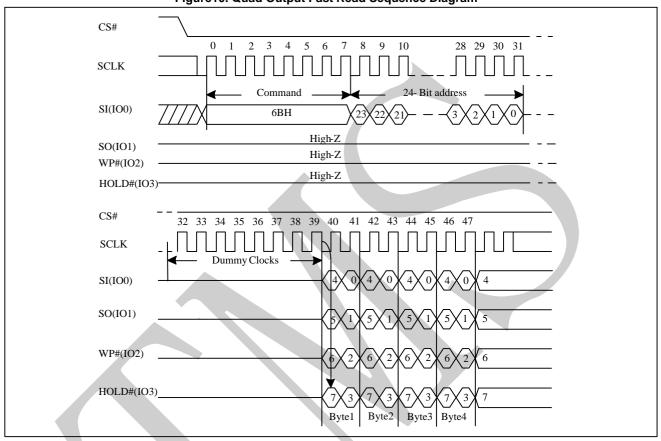


Figure10. Quad Output Fast Read Sequence Diagram

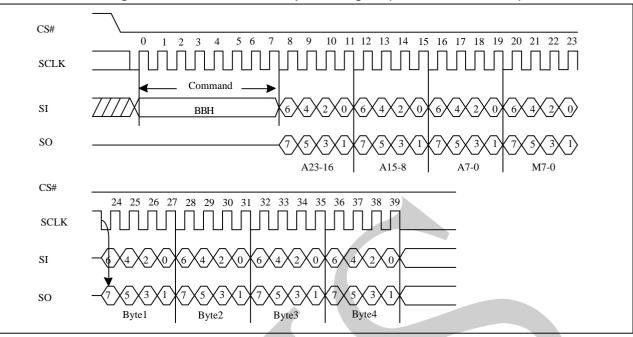
7.10. Dual I/O Fast Read (BBH)

The Dual I/O Fast Read command is similar to the Dual Output Fast Read command but with the capability to input the 3-Byte address (A23-0) and a "Continuous Read Mode" Byte 2-bit per clock by SI and SO, and each bit is latched in on the rising edge of SCLK, then the memory contents are shifted out 2-bit per clock cycle from SI and SO. The command sequence is shown in followed Figure 11. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

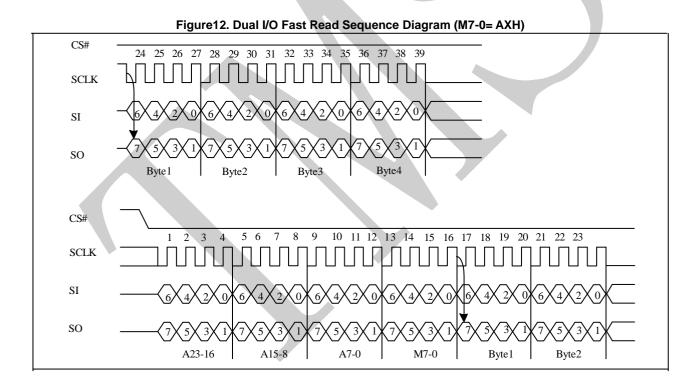
Dual I/O Fast Read with "Continuous Read Mode"

The Dual I/O Fast Read command can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-Byte address (A23-A0). If the "Continuous Read Mode" bits (M7-0) =AXH, then the next Dual I/O Fast Read command (after CS# is raised and then lowered) does not require the BBH command code. The command sequence is shown in followed Figure 11. If the "Continuous Read Mode" bits (M7-0) are any value other than AXH, the next command requires the first BBH command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M7-0) before issuing normal command.







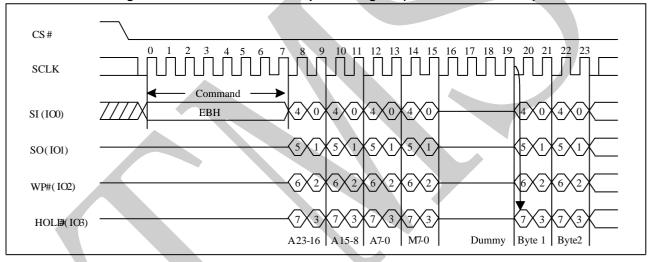


7.11. Quad I/O Fast Read (EBH)

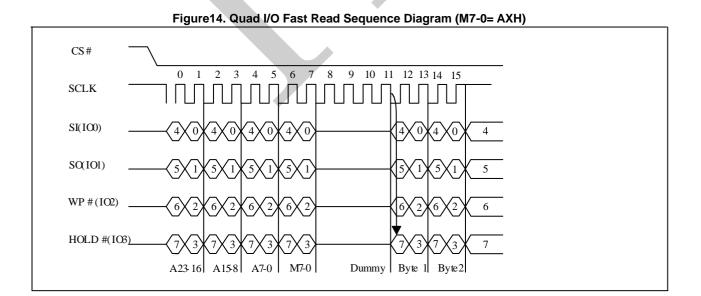
The Quad I/O Fast Read command is similar to the Dual I/O Fast Read command but with the capability to input the 3-Byte address (A23-0) and a "Continuous Read Mode" Byte and 4-dummy clock 4-bit per clock by IO0, IO1, IO2, IO3, each bit being latched in during the rising edge of SCLK, then the memory contents are shifted out 4-bit per clock cycle from IO0, IO1, IO2, IO3. The command sequence is shown in followed Figure 13. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. The Quad Enable bit (QE) of Status Register (S9) must be set to enable for the Quad I/O Fast read command.

Quad I/O Fast Read with "Continuous Read Mode"

The Quad I/O Fast Read command can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-Byte address (A23-A0). If the "Continuous Read Mode" bits (M7-0) =AXH, then the next Quad I/O Fast Read command (after CS# is raised and then lowered) does not require the EBH command code. The command sequence is shown in followed Figure 13. If the "Continuous Read Mode" bits (M7-0) are any value other than AXH, the next command requires the first EBH command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M7-0) before issuing normal command.







7.12. Quad I/O Word Fast Read (E7H)

The Quad I/O Word Fast Read command is similar to the Quad I/O Fast Read command except that the lowest address bit (A0) must be equal 0 and there are only 2-dummy clock. The command sequence is shown in followed Figure 15. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. The Quad Enable bit (QE) of Status Register (S9) must be set to enable for the Quad I/O Word Fast read command.

Quad I/O Word Fast Read with "Continuous Read Mode"

The Quad I/O Word Fast Read command can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-Byte address (A23-A0). If the "Continuous Read Mode" bits (M7-0) =AXH, then the next Quad I/O Word Fast Read command (after CS# is raised and then lowered) does not require the E7H command code. The command sequence is shown in followed Figure 15. If the "Continuous Read Mode" bits (M7-0) are any value other than AXH, the next command requires the first E7H command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M7-0) before issuing normal command.

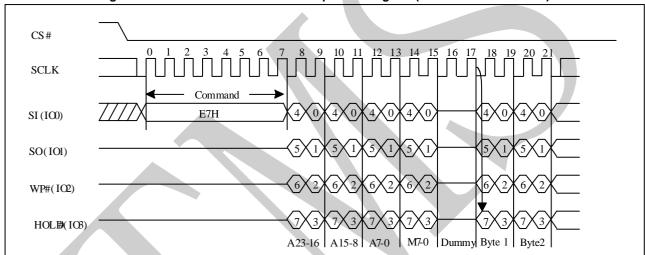
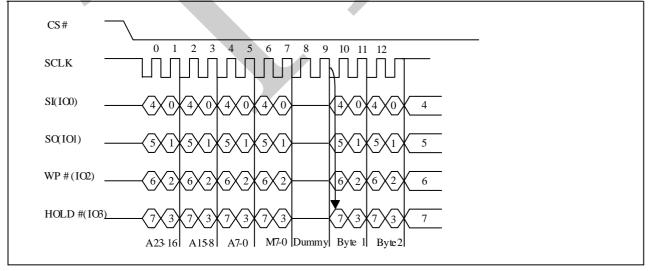


Figure 15. Quad I/O Word Fast Read Sequence Diagram (M7-0= 0XH or not AXH)

Figure16. Quad I/O Word Fast Read Sequence Diagram (M7-0= AXH)



7.13. Set Burst with Wrap (77H)

The Set Burst with Wrap command is used in conjunction with "Quad I/O Fast Read" and "Quad I/O Word Fast Read" command to access a fixed length of 8/16/32/64-byte section within a 256-byte page.

The Set Burst with Wrap command sequence: CS# goes low \rightarrow Send Set Burst with Wrap command \rightarrow Send 24 dummy bits \rightarrow Send 8 bits "Wrap bits" \rightarrow CS# goes high.

W6,W5	W4=0		W4=1 (default)	
	Wrap Aroud	Wrap Length	Wrap Aroud	Wrap Length
0,0	Yes	8-byte	No	N/A
0,1	Yes	16-byte	No	N/A
1,0	Yes	32-byte	No	N/A
1,1	Yes	64-byte	No	N/A

If the W6-W4 bits are set by the Set Burst with Wrap command, all the following "Quad I/O Fast Read" and "Quad I/O Word Fast Read" command will use the W6-W4 setting to access the 8/16/32/64-byte section within any page. To exit the "Wrap Around" function and return to normal read operation, another Set Burst with Wrap command should be issued to set W4=1.

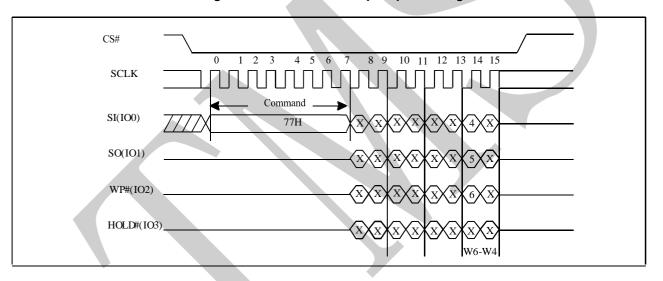


Figure17. Set Burst with Wrap Sequence Diagram

7.14. Page Program (PP) (02H)

The Page Program (PP) command is for programming the memory. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command.

The Page Program (PP) command is entered by driving CS# Low, followed by the command code, three address Bytes and at least one data Byte on SI. If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 8 least significant bits (A7-A0) are all zero). CS# must be driven low for the entire duration of the sequence. The Page Program command sequence: CS# goes low \rightarrow sending Page Program command \rightarrow 3-Byte address on SI \rightarrow at least 1 Byte data on SI \rightarrow CS# goes high. The command sequence is shown in Figure 18. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. CS# must be driven high after the eighth bit of the last data Byte has been latched in; otherwise the Page Program (PP) command is not executed.

As soon as CS# is driven high, the self-timed Page Program cycle (whose duration is tPP) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) command applied to a page which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) is not executed.

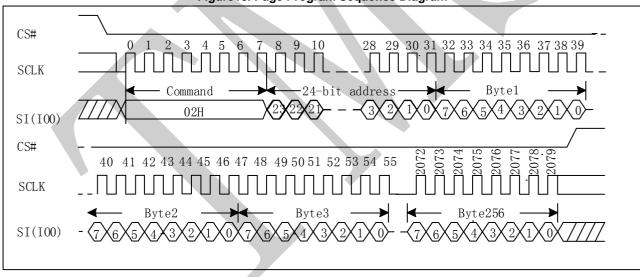


Figure18. Page Program Sequence Diagram

7.15. Dual Input Page Program (A2H)

The Dual Input Page Program command is for programming the memory using two pins: IO0, IO1. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Dual Input Page Program command. The quad Page Program command is entered by driving CS# Low, followed by the command code (A2H), three address Bytes and at least one data Byte on IO pins.

The command sequence is shown in Figure19. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. CS# must be driven high after the eighth bit of the last data Byte has been latched in; otherwise the Dual Input Page Program command is not executed.

As soon as CS# is driven high, the self-timed Dual Input Page Program cycle (whose duration is tPP) is initiated. While the Dual Input Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Dual Input Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Dual Input Page Program command applied to a page which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) is not executed.

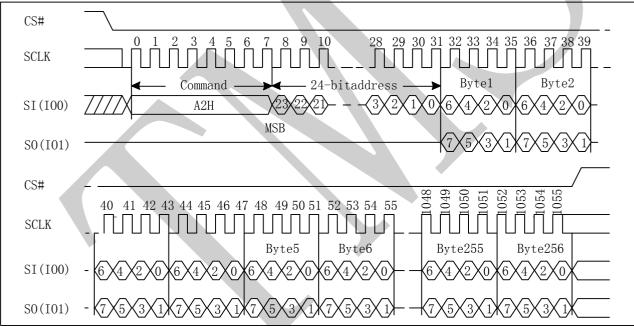


Figure 19. Dual input Page Program Sequence Diagram

7.16. Quad Page Program (32H)

The Quad Page Program command is for programming the memory using four pins: IO0, IO1, IO2, and IO3. To use Quad Page Program the Quad enable in status register Bit9 must be set (QE=1). A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command. The quad Page Program command is entered by driving CS# Low, followed by the command code (32H), three address Bytes and at least one data Byte on IO pins.

The command sequence is shown in Figure20. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. CS# must be driven high after the eighth bit of the last data Byte has been latched in; otherwise the Quad Page Program (PP) command is not executed.

As soon as CS# is driven high, the self-timed Quad Page Program cycle (whose duration is tPP) is initiated. While the Quad Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Quad Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Quad Page Program command applied to a page which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) is not executed.

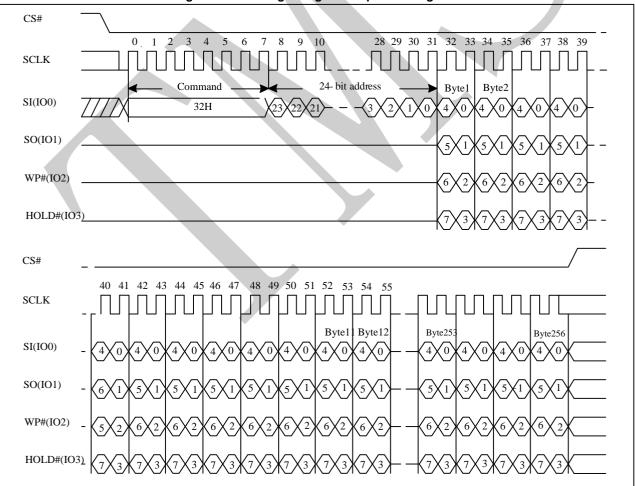
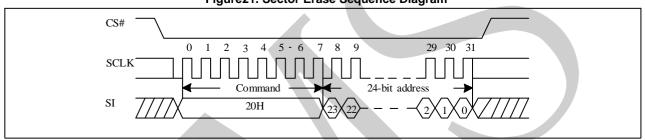


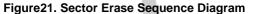
Figure20.Quad Page Program Sequence Diagram

7.17. Sector Erase (SE) (20H)

The Sector Erase (SE) command is used to erase all the data of the chosen sector. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The Sector Erase (SE) command is entered by driving CS# low, followed by the command code, and 3-address Byte on SI. Any address inside the sector is a valid address for the Sector Erase (SE) command. CS# must be driven low for the entire duration of the sequence.

The Sector Erase command sequence: CS# goes low \rightarrow sending Sector Erase command \rightarrow 3-Byte address on SI \rightarrow CS# goes high. The command sequence is shown in Figure21. CS# must be driven high after the eighth bit of the last address Byte has been latched in; otherwise the Sector Erase (SE) command is not executed. As soon as CS# is driven high, the self-timed Sector Erase cycle (whose duration is tSE) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A Sector Erase (SE) command applied to a sector which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bit (see Table1&1a) is not executed.





7.18. 32KB Block Erase (BE) (52H)

The 32KB Block Erase (BE) command is used to erase all the data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 32KB Block Erase (BE) command is entered by driving CS# low, followed by the command code, and three address Bytes on SI. Any address inside the block is a valid address for the 32KB Block Erase (BE) command. CS# must be driven low for the entire duration of the sequence.

The 32KB Block Erase command sequence: CS# goes low \rightarrow sending 32KB Block Erase command \rightarrow 3-Byte address on SI \rightarrow CS# goes high. The command sequence is shown in Figure22. CS# must be driven high after the eighth bit of the last address Byte has been latched in; otherwise the 32KB Block Erase (BE) command is not executed. As soon as CS# is driven high, the self-timed Block Erase cycle (whose duration is tBE) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 32KB Block Erase (BE) command applied to a block which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits (see Table1&1a) is not executed.



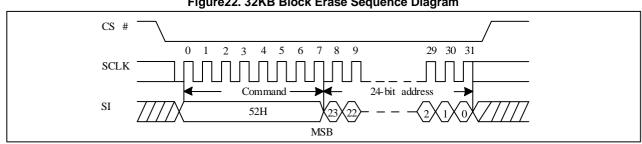
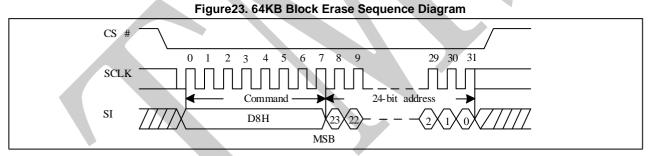


Figure22. 32KB Block Erase Sequence Diagram

7.19. 64KB Block Erase (BE) (D8H)

The 64KB Block Erase (BE) command is used to erase all the data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 64KB Block Erase (BE) command is entered by driving CS# low, followed by the command code, and three address Bytes on SI. Any address inside the block is a valid address for the 64KB Block Erase (BE) command. CS# must be driven low for the entire duration of the sequence.

The 64KB Block Erase command sequence: CS# goes low \rightarrow sending 64KB Block Erase command \rightarrow 3-Byte address on SI → CS# goes high. The command sequence is shown in Figure 23. CS# must be driven high after the eighth bit of the last address Byte has been latched in; otherwise the 64KB Block Erase (BE) command is not executed. As soon as CS# is driven high, the self-timed Block Erase cycle (whose duration is tBE) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 64KB Block Erase (BE) command applied to a block which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits (see Table1&1a) is not executed.



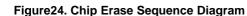
7.20. Chip Erase (CE) (60/C7H)

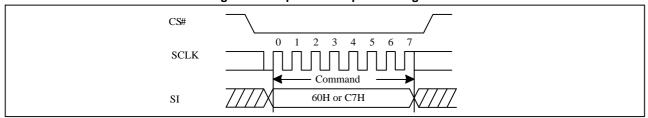
The Chip Erase (CE) command is used to erase all the data of the chip. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit .The Chip Erase (CE) command is entered by driving CS# Low, followed by the command code on Serial Data Input (SI). CS# must be driven Low for the entire duration of the sequence.

The Chip Erase command sequence: CS# goes low \rightarrow sending Chip Erase command \rightarrow CS# goes high. The command sequence is shown in Figure 24. CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Chip Erase command is not executed. As soon as CS# is driven high, the self-timed Chip Erase cycle (whose duration is tCE) is initiated. While the Chip Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Chip Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Chip Erase (CE) command is executed if the Block Protect (BP2, BP1, and BP0) bits are 0 and CMP=0 or the Block Protect (BP2, BP1, and BP0) bits are 1 and CMP=1. The Chip Erase (CE) command is ignored if one or more sectors are



protected.



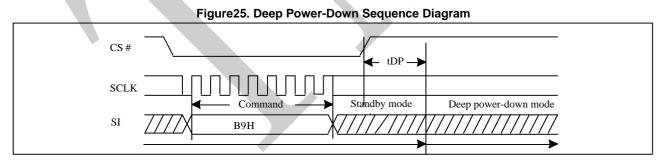


7.21. Deep Power-Down (DP) (B9H)

Executing the Deep Power-Down (DP) command is the only way to put the device in the lowest consumption mode (the Deep Power-Down Mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase commands. Driving CS# high deselects the device, and puts the device in the Standby Mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-Down Mode. The Deep Power-Down Mode can only be entered by executing the Deep Power-Down (DP) command. Once the device has entered the Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down and Read Device ID (RDI) command. These commands can release the device from this mode. The Release from Deep Power-Down and Read Device ID (RDI) command releases the device from deep power down mode , also allows the Device ID of the device to be output on SO.

The Deep Power-Down Mode automatically stops at Power-Down, and the device is in the Standby Mode after Power-Up.

The Deep Power-Down command sequence: CS# goes low \rightarrow sending Deep Power-Down command \rightarrow CS# goes high. The command sequence is shown in Figure25. CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Deep Power-Down (DP) command is not executed. As soon as CS# is driven high, it requires a delay of tDP before the supply current is reduced to ICC2 and the Deep Power-Down Mode is entered. Any Deep Power-Down (DP) command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



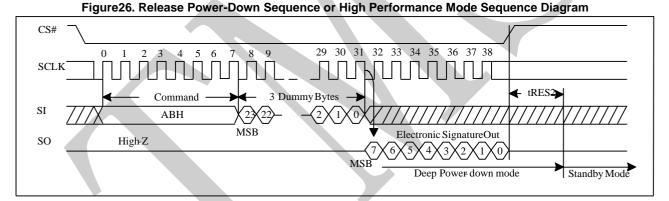
7.22. Release from Deep Power-Down or High Performance Mode and Read Device ID (RDI) (ABH)

The Release from Power-Down or High Performance Mode / Device ID command is a multi-purpose command. It can be used to release the device from the Power-Down state or High Performance Mode or obtain the devices electronic identification (ID) number.

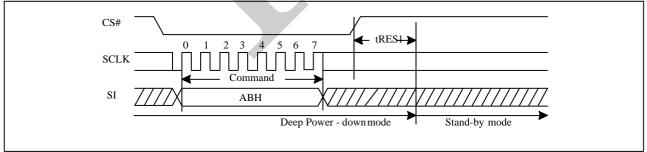
To release the device from the Power-Down state or High Performance Mode, the command is issued by driving the CS# pin low, shifting the instruction code "ABH" and driving CS# high as shown in Figure26. Release from Power-Down will take the time duration of tRES1 (See AC Characteristics) before the device will resume normal operation and other c omma nd are accepted. The CS# pin must remain high during the tRES1 time duration.

When used only to obtain the Device ID while not in the Power-Down state, the command is initiated by driving the CS# pin low and shifting the instruction code "ABH" followed by 3-dummy Byte. The Device ID bits are then shifted out on the falling edge of SCLK with most significant bit (MSB) first as shown in Figure27. The Device ID value is listed in Manufacturer and Device Identification table. The Device ID can be read continuously. The command is completed by driving CS# high.

When used to release the device from the Power-Down state and obtain the Device ID, the command is the same as previously described, and shown in Figure27, except that after CS# is driven high it must remain high for a time duration of tRES2 (See AC Characteristics). After this time duration the device will resume normal operation and other command will be accepted. If the Release from Power-Down / Device ID command is issued while an Erase, Program or Write cycle is in process (when WIP equal 1) the command is ignored and will not have any effects on the current cycle.







7.23. Read Manufacture ID/ Device ID (REMS) (90H)

The Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID.

The command is initiated by driving the CS# pin low and shifting the command code "90H" followed by a 24-bit address (A23-A0) of 000000H. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first as shown in Figure 28. If the 24-bit address is initially set to 000001H, the Device ID will be read first.

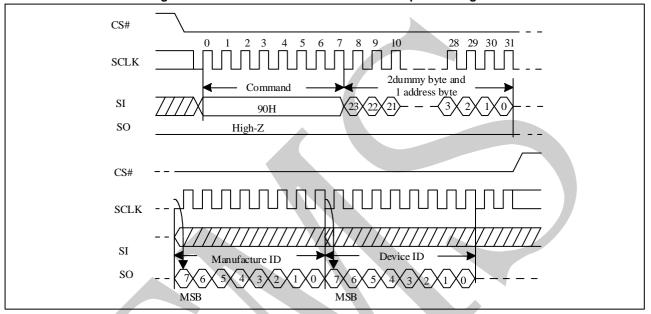
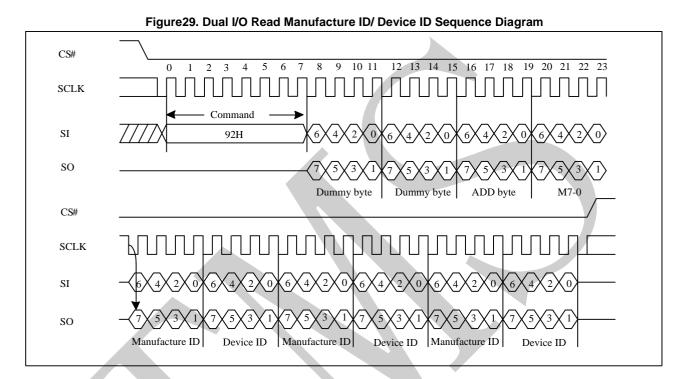


Figure28. Read Manufacture ID/ Device ID Sequence Diagram

7.24. Dual I/O Read Electronic Manufacturer ID/ Device ID (92H)

The Dual I/O Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID by dual I/O.

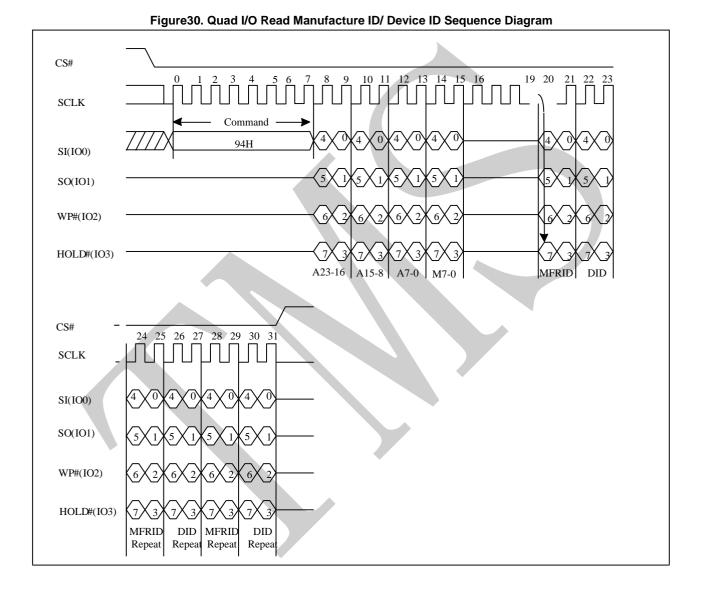
The command is initiated by driving the CS# pin low and shifting the command code "92H" followed by a 24-bit address (A23-A0) of 000000H. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first as shown in Figure29. If the 24-bit address is initially set to 000001H, the Device ID will be read first.



7.25. Quad I/O Read Electronic Manufacturer ID/ Device ID (94H)

The Quad I/O Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID by quad I/O.

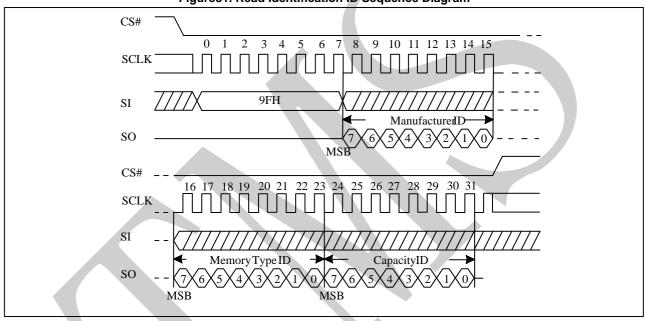
The command is initiated by driving the CS# pin low and shifting the command code "94H" followed by a 24-bit address (A23-A0) of 000000H, and 4 dummy clocks. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first as shown in Figure 30. If the 24-bit address is initially set to 000001H, the Device ID will be read first.

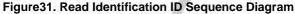


7.26. Read Identification (RDID) (9FH)

The Read Identification (RDID) command allows the 8-bit manufacturer identification to be read, followed by two Bytes of device identification. The device identification indicates the memory type in the first Byte, and the memory capacity of the device in the second Byte. The Read Identification (RDID) command while an Erase or Program cycle is in progress is not decoded, and has no effect on the cycle that is in progress. The Read Identification (RDID) command should not be issued while the device is in Deep Power-Down Mode.

The device is first selected by driving CS# low. Then, the 8-bit command code for the command is shifted in. This is followed by the 24-bit device identification, stored in the memory, Each bit is shifted out on the falling edge of Serial Clock. The command sequence is shown in Figure31. The Read Identification (RDID) command is terminated by driving CS# high at any time during data output. When CS# is driven high, the device is in the Standby Mode. Once in the Standby Mode, the device waits to be selected, so that it can receive, decode and execute commands.

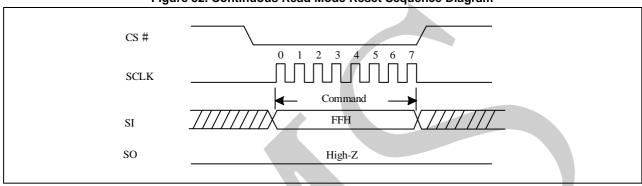




7.27. Continuous Read Mode Reset (CRMR) (FFH)

The Dual/Quad I/O Fast Read operations, "Continuous Read Mode" bits (M7-0) are implemented to further reduce command overhead. By setting the (M7-0) to AXH, the next Dual/Quad I/O Fast Read operations do not require the BBH/EBH/E7H command code.

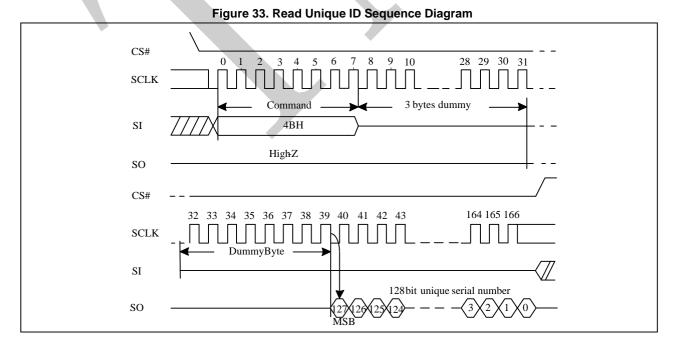
Because the TH25Q-16UB has no hardware reset pin, so if Continuous Read Mode bits are set to "AXH", the TH25Q-16UB will not recognize any standard SPI commands. So Continuous Read Mode Reset command will release the Continuous Read Mode from the "AXH" state and allow standard SPI command to be recognized. The command sequence is show in Figure 32.





7.28. Read Unique ID (4BH)

The Read Unique ID command accesses a factory-set read-only 128bit number that is unique to each TH25Q-16UB device. The Unique ID can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID command sequence: CS# goes low \rightarrow sending Read Unique ID command \rightarrow Dummy Byte1 \rightarrow Dummy Byte2 \rightarrow Dummy Byte3 \rightarrow Dummy Byte4 \rightarrow 128bit Unique ID Out \rightarrow CS# goes high. The command sequence is show below.



7.29. Program/Erase Suspend (PES) (75/B0H)

The Program/Erase Suspend command "75/B0H", allows the system to interrupt a page program or sector/block erase operation and then read data from any other sector or block. The Write Status Register command (01H) and Erase/Program Security Registers command (44H,42H) and Erase commands (20H, 52H, D8H, C7H, 60H) and Page Program command (02H / 32H) are not allowed during Program suspend. The Write Status Register command (01H) and Erase Security Registers command (44H) and Erase commands (20H, 52H, D8H, C7H, 60H) are not allowed during Erase suspend. Program/Erase Suspend is valid only during the page program or sector/block erase operation. A maximum of time of "tsus" (See AC Characteristics) is required to suspend the program/erase operation.

The Program/Erase Suspend command will be accepted by the device only if the SUS bit in the Status Register equal to 0 and WIP bit equal to 1 while a Page Program or a Sector or Block Erase operation is on-going. If the SUS bit equal to 1 or WIP bit equal to 0, the Suspend command will be ignored by the device. The WIP bit will be cleared from 1 to 0 within "tsus" and the SUS bit will be set from 0 to 1 immediately after Program/Erase Suspend. A power-off during the suspend period will reset the device and release the suspend state. The command sequence is show in Figure 34.

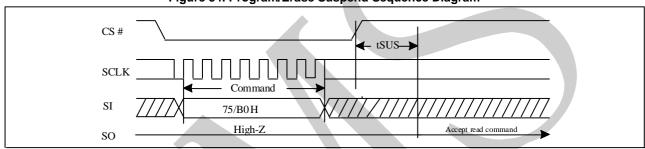
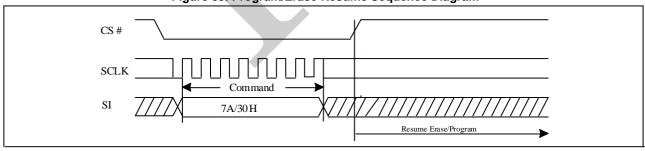


Figure 34. Program/Erase Suspend Sequence Diagram

7.30. Program/Erase Resume (PER) (7A/30H)

The Program/Erase Resume command must be written to resume the program or sector/block erase operation after a Program/Erase Suspend command. The Program/Erase Resume command will be accepted by the device only if the SUS bit equal to 1 and the WIP bit equal to 0. After issued the SUS bit in the status register will be cleared from 1 to 0 immediately, the WIP bit will be set from 0 to 1 within 200ns and the Sector or Block will complete the erase operation or the page will complete the program operation. The Program/Erase Resume command will be ignored unless a Program/Erase Suspend is active. The command sequence is show in Figure35.





7.31. Erase Security Registers (44H)

The TH25Q-16UB provides four 256-Byte Security Registers which can be read and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

The Erase Security Registers command is similar to Sector/Block Erase command. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit.

The Erase Security Registers command sequence: CS# goes low \rightarrow sending Erase Security Registers command \rightarrow 3-Byte address on SI →CS# goes high. The command sequence is shown in Figure36. CS# must be driven high after the eighth bit of the command code has been latched in, otherwise the Erase Security Registers command is not executed. As soon as CS# is driven high, the self-timed Erase Security Registers cycle (whose duration is tSE) is initiated. While the Erase Security Registers cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Erase Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Security RegistersLock Bit (LB) in the Status Register can be used to OTP protect the security registers. Once the LB bit is set to 1, the Security Registers will be permanently locked; the Erase Security Registers command will be ignored.

Address	A23-A16	A15-A8	A7-A0
Security Registers0	00Н	00H	Don't Care
Security Registers1	00Н	01H	Don't Care
Security Registers2	00Н	02H	Don't Care
Security Registers3	00H	03H	Don't Care

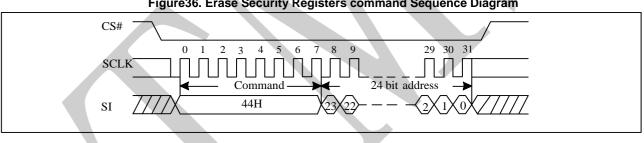


Figure36. Erase Security Registers command Sequence Diagram

7.32. Program Security Registers (42H)

The Program Security Registers command is similar to the Page Program command. Each security register contains one pages content. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Program Security Registers command. The Program Security Registers command is entered by driving CS# Low, followed by the command code (42H), three address Bytes and at least one data Byte on SI. As soon as CS# is driven high, the self-timed Program Security Registers cycle (whose duration is tPP) is initiated. While the Program Security Registers cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Program Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

If the Security Registers Lock Bit (LB) is set to 1, the Security Registers will be permanently locked. Program Security Registers command will be ignored.

Address	A23-A16	A15-A8	A7-A0
Security Registers 0	00H	00H	Byte Address
Security Registers 1	00H	01H	Byte Address
Security Registers 2	TS POC TENG Mici	osystem Co?Etd	Byte Address
Security Registers 3	00H	03H	Byte Address



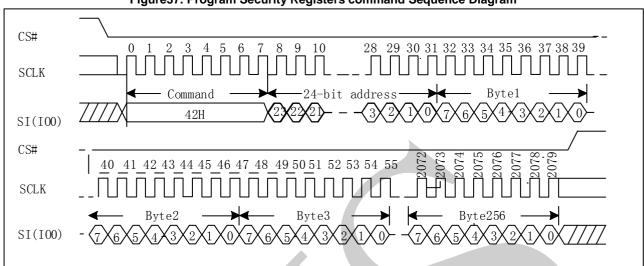


Figure37. Program Security Registers command Sequence Diagram

7.33. Read Security Registers (48H)

The Read Security Registers command is similar to Fast Read command. The command is followed by a 3-Byte address (A23-A0) and a dummy Byte, and each bit is latched-in on the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, and each bit is shifted out, at a Max frequency fC, on the falling edge of SCLK. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. Once the A7-A0 address reaches the last Byte of the register (Byte FFH), it will reset to 00H, the command is completed by driving CS# high.

Address	A23-A16	A15-A8	A7-A0
Security Registers 0	00H	00Н	Byte Address
Security Registers 1	00H	01H	Byte Address
Security Registers 2	00H	02H	Byte Address
Security Registers 3	00Н	03H	Byte Address

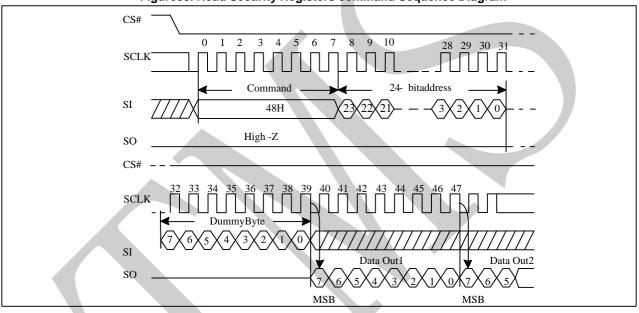
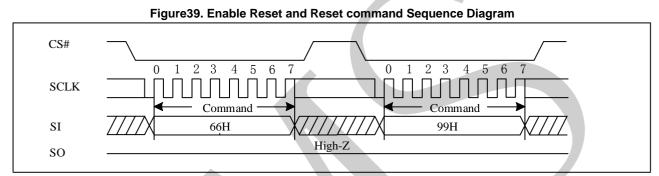


Figure 38. Read Security Registers command Sequence Diagram

7.34. Enable Reset (66H) and Reset (99H)

If the Reset command is accepted, any on-going internal operation will be terminated and the device will return to its default power-on state and lose all the current volatile settings, such as Volatile Status Register bits, Write Enable Latch status (WEL), Program/Erase Suspend status, Read Parameter setting (P7-P0), Continuous Read Mode bit setting (M7-M0) and Wrap Bit Setting (W6-W4).

The "Reset (99H)" command sequence as follow: CS# goes low \rightarrow Sending Enable Reset command \rightarrow CS# goes high \rightarrow CS# goes low \rightarrow Sending Reset command \rightarrow CS# goes high. Once the Reset command is accepted by the device, the device will take approximately tRST = 30us /120us / 4ms to reset. During this period, no command will be accepted. Data corruption may happen if there is an on-going or suspended internal Erase or Program operation when Reset command sequence is accepted by the device. It is recommended to check the BUSY bit and the SUS bit in Status Register before issuing the Reset command sequence.



7.35. Read Serial Flash Discoverable Parameter (5AH)

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI. SFDP is a standard of JEDEC Standard No.216.

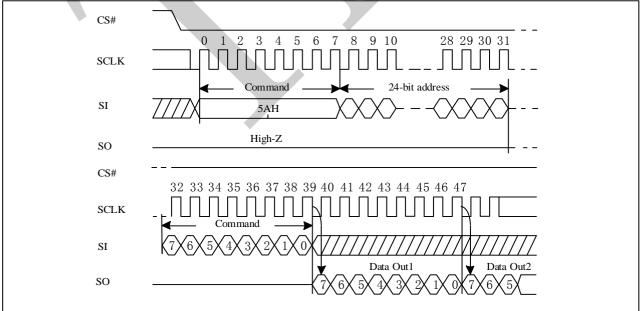


Figure 40. Read Serial Flash Discoverable Parameter command Sequence Diagram



Description	Comment	Add(H)	DW Add	Data	Data
		(Byte)	(Bit)		
SFDP Signature	Fixed:50444653H	00H	07:00	53H	53H
		01H	15:08	46H	46H
		02H	23:16	44H	44H
		03H	31:24	50H	50H
SFDP Minor Revision Number	Start from 00H	04H	07:00	06H	06H
SFDP Major Revision Number	Start from 01H	05H	15:08	01H	01H
Number of Parameters Headers	Start from 00H	06H	23:16	01H	01H
Unused	Contains 0xFFH and can never	07H	31:24	FFH	FFH
	be changed				
ID number (JEDEC)	00H: It indicates a JEDEC	08H	07:00	00H	00H
	specified header				
Parameter Table Minor	Start from 0x00H	09H	15:08	06H	06H
Revision Number					
Parameter Table Major	Start from 0x01H	0AH	23:16	01H	01H
Revision Number					
Parameter Table Length	How many DWORDs in the	OBH	31:24	09H	09H
(in double word)	Parameter table				
Parameter Table Pointer (PTP)	First address of JEDEC Flash	ОСН	07:00	30H	30H
	Parameter table	0DH	15:08	00H	00H
		0EH	23:16	00H	00H
Unused	Contains 0xFFH and can never	0FH	31:24	FFH	FFH
	be changed				
ID Number	It is indicates TMS Device	10H	07:00	EBH	EBH
(TMS Device Manufacturer ID)	manufacturer ID				
Parameter Table Minor	Start from 0x00H	11H	15:08	00H	00H
Revision Number					
Parameter Table Major	Start from 0x01H	12H	23:16	01H	01H
Revision Number					
Parameter Table Length	How many DWORDs in the	13H	31:24	03H	03H
(in double word)	Parameter table				
Parameter Table Pointer (PTP)	First address of TMS Device	14H	07:00	60H	60H
	Flash Parameter table	15H	15:08	00H	00H
		16H	23:16	00H	00H
Unused	Contains 0xFFH and can never	17H	31:24	FFH	FFH
	be changed				

Table3. Signature and Parameter Identification Data Values



Table4. Parameter Table (0): JEDEC Flash Parameter Tables							
Description	Comment	Add(H)	DW Add	Data	Data		
		(Byte)	(Bit)				
	00: Reserved; 01: 4KB erase;						
Block/Sector Erase Size	10: Reserved;		01:00	01b			
	11: not support 4KB erase	-					
Write Granularity	0: 1Byte, 1: 64Byte or larger	-	02	1b			
Write Enable Instruction	0: Nonvolatile status bit						
Requested for Writing to	1: Volatile status bit (BP		03	0b			
Volatile			05	00			
Status Registers	status register bit)	30Н			E5H		
	0: Use 50H Opcode, 1:	3011			LJII		
Write Enable Opcode Select for	Use 06H Opcode,		*				
Writing to Volatile Status Registers	Note: If target flash status		04	0b			
	register is Nonvolatile, then bits 3						
	and 4 must be set to 00b.						
	Contains 111b and can never be						
Unused	changed		07:05	111b			
4KB Erase Opcode		31H	15:08	20H	20H		
(1-1-2) Fast Read	0=Not support, 1=Support		16	1b			
Address Bytes Number used in	00: 3Byte only, 01: 3 or 4Byte,						
addressing flash array	10: 4Byte only, 11: Reserved		18:17	00b			
Double Transfer Rate (DTR)							
clocking	0=Not support, 1=Support	32H	19	0b	F1H		
(1-2-2) Fast Read	0=Not support, 1=Support	5211	20	1b	L T I I		
(1-4-4) Fast Read	0=Not support, 1=Support		21	1b			
(1-1-4) Fast Read	0=Not support, 1=Support		22	1b			
Unused			23	1b			
Unused		33H	31:24	FFH	FFH		
		37H:34					
Flash Memory Density		н	31:00	00FFFFF	FH		
(1-4-4) Fast Read Number of	00000b: Wait states (Dummy						
Wait states	Clocks) not support		04:00	00100b			
(1-4-4) Fast Read Number of		38H			44H		
Mode Bits	000b:Mode Bits not support		07:05	010b			
(1-4-4) Fast Read Opcode		39H	15:08	EBH	EBH		
(1-1-4) Fast Read Number of	0 0000b: Wait states (Dummy						
Wait states	Clocks) not support		20:16	01000b			
(1-1-4) Fast Read Number of		3AH			08H		
Mode Bits	000b:Mode Bits not support		23:21	000b			
(1-1-4) Fast Read Opcode		ЗВН	31:24	6BH	6BH		
(1 1 -) i ast nead Opcode			J1.24				

Table4. Parameter Table (0): JEDEC Flash Parameter Tables



Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data	
(1-1-2) Fast Read Number of	0 0000b: Wait states (Dummy		04:00	01000b		
Wait states	Clocks) not support	ЗСН	04.00	010000	08H	
(1-1-2) Fast Read Number of Mode Bits	000b: Mode Bits not support	SCH	07:05	07:05 000b		
(1-1-2) Fast Read Opcode		3DH	15:08	3BH	3BH	
(1-2-2) Fast Read Number	0 0000b: Wait states (Dummy					
of Wait states	Clocks) not support		20:16	00000b		
(1-2-2) Fast Read Number of Mode Bits	000b: Mode Bits not support	3EH	23:21	100b	80H	
(1-2-2) Fast Read Opcode		3FH	31:24	BBH	BBH	
(2-2-2) Fast Read	0=not support 1=support		00	0b		
Unused			03:01	111b	-	
(4-4-4) Fast Read	0=not support 1=support	40H	04	Ob	EEH	
Unused			07:05	111b	1	
Unused		43H:41H	31:08	0xFFH	0xFFH	
Unused		45H:44H	15:00	0xFFH	0xFFH	
(2-2-2) Fast Read Number	0 0000b: Wait states (Dummy		20.46	000001		
of Wait states	Clocks) not support	4611	20:16	00000b	0011	
(2-2-2) Fast Read Number	000b: Mode Bits not support	- 46H	23:21	000b	00H	
of Mode Bits	boob. Mode bits not support		23.21	0000		
(2-2-2) Fast Read Opcode		47H	31:24	FFH	FFH	
Unused		49H:48H	15:00	0xFFH	0xFFH	
(4-4-4) Fast Read Number of	0 0000b: Wait states (Dummy Clocks) not support		20:16	00000b		
Wait states		4AH			00H	
(4-4-4) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	000b	1	
(4-4-4) Fast Read Opcode		4BH	31:24	FFH	FFH	
Sector Type 1 Size	Sector/block size=2^N Bytes 0x00b: this sector type don't exist	4CH	07:00	0CH	0CH	
Sector Type 1 erase Opcode		4DH	15:08	20H	20H	
Sector Type 2 Size	Sector/block size=2^N Bytes 0x00b: this sector type don't exist	4EH	23:16	OFH	OFH	
Sector Type 2 erase Opcode		4FH	31:24	52H	52H	
Sector Type 3 Size	Sector/block size=2^N Bytes 0x00b: this sector type don't exist	50H	07:00	10H	10H	
Sector Type 3 erase Opcode		51H	15:08	D8H	D8H	
Sector Type 4 Size	Sector/block size=2^N Bytes 0x00b: this sector type don't exist	52H	23:16	00H	00H	
Sector Type 4 erase Opcode	,, , , , , , , , , , , , , , , , , , ,	53H	31:24	FFH	FFH	

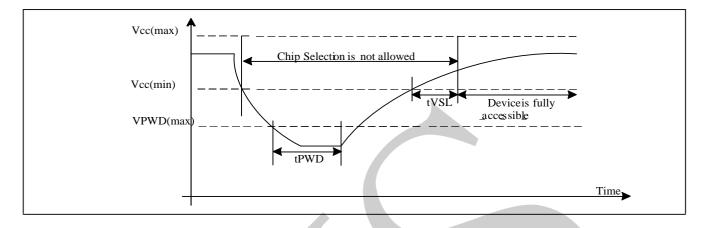


	ameter Table (T): TWS Device F				
Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
Vcc Supply Maximum Voltage	2000H=2.000V 2700H=2.700V 3600H=3.600V	61Н:60 Н	15:00	3600H	3600H
Vcc Supply Minimum Voltage	1650H=1.650V 2250H=2.250V 2300H=2.300V 2700H=2.700V	63Н:62 Н	31:16	1650H	1650H
HW Reset# pin	0=not support 1=support		00	0b	
HW Hold# pin	0=not support 1=support		01	1b	
Deep Power Down Mode	0=not support 1=support		02	1b	
SW Reset	0=not support 1=support	1	03	1b	
SW Reset Opcode	Should be issu Reset Enable(66H) before Reset cmd.	65Н:64 Н	11:04	99H	F99EH
Program Suspend/Resume	0=not support 1=support		12	1b	
Erase Suspend/Resume	0=not support 1=support		13	1b	
Unused		-	14	1b	
Wrap-Around Read mode	0=not support 1=support		15	1b	
Wrap-Around Read mode Opcode		66H	23:16	77H	77H
Wrap-Around Read data length	08H:support 8B wrap-around read 16H:8B&16B 32H:8B&16B&32B 64H:8B&16B&32B&64B	67H	31:24	64H	64H
Individual block lock	0=not support 1=support		00	0b	
Individual block lock bit (Volatile/Nonvolatile)	0=Volatile 1=Nonvolatile		01	0b	
Individual block lock Opcode		-	09:02	FFH	
Individual block lock Volatile protect bit default protect status	0=protect 1=unprotect	6BH:68	10	0b	EBFCH
Secured OTP	0=not support 1=support	н	11	1b	
Read Lock	0=not support 1=support]	12	0b	
Permanent Lock	0=not support 1=support		13	1b	
Unused]	15:14	11b	
		1	31:16	FFFFH	FFFFH

Table5. Parameter Table (1): TMS Device Flash Parameter Tables

8. ELECTRICAL CHARACTERISTICS

8.1. POWER-ON Down and Voltage Drop TIMING



Symbol	Parameter	Min.	Max.	Unit
VPWD	VCC voltage needed to below VPWD for ensuring initialization will occur		1	V
tPWD	The minimum duration for ensuring initialization will occur	300		us
tVSL	VCC (min) To CS# Low	50	1000	us
VWI	Write Inhibit Voltage	1.45	1.55	V

8.2. INITIAL DELIVERY STATE

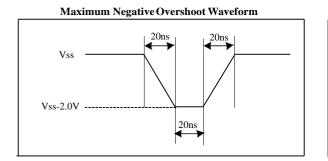
The device is delivered with the memory array erased: all bits are set to 1(each Byte contains FFH). The Status Register contains 00H (all Status Register bits are 0).

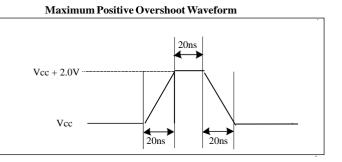
8.3. ABSOLUTE MAXIMUM RATINGS

Parameter	Value	Unit
Ambient Operating Temperature	-40 to 105	°C
Storage Temperature	-65 to 150	°C
Applied Input / Output Voltage	-0.6 to VCC+0.4	V
Transient Input / Output Voltage(note: overshoot)	-2.0 to VCC+2.0	V
VCC	-0.6 to 4.2	V



Figure41. Maximum Negative and Positive Overshoot Waveform

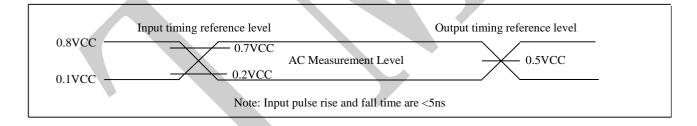




8.4. CAPACITANCE MEASUREMENT CONDITIONS

Symbol	Parameter	Min.	Тур.	Max.	Unit	Conditions
CIN	Input Capacitance			6	pF	VIN=0V
COUT	Output Capacitance			8	pF	VOUT=0V
CL	Load Capacitance		30		pF	
	Input Rise And Fall time			5	ns	
	Input Pulse Voltage	0.1VCC	to 0.8VCC		v	
	Input Timing Reference Voltage	0.2VCC	to 0.7VCC		V	
	Output Timing Reference Voltage		0.5VCC		V	

Figure39:Input Test Waveform and Measurement Level



8.5. DC CHARACTERISTICS

(T= -40°C~85°C, VCC=1.65~3.6V)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit.
lu	Input Leakage Current				±2	μΑ
ILO	Output Leakage Current				±2	μA
Icc1	Standby Current	CS#=VCC,		10		μA
		V _{IN} =VCC or VSS				
Icc2	Deep Power-Down Current	CS#=VCC,		0.65	28	μA
		V _{IN} =VCC or VSS				
		CLK=0.1VCC /				
		0.9VCC				
		at 104MHz,		2.5	3.8	mA
	Operating Current (OD Dead)	Q=Open(*1,*2,*4 I/O)				
I _{CC3}	Operating Current (OB Read)	CLK=0.1VCC /				
		0.9VCC				
		at 80MHz,		2.1	3.2	mA
		Q=Open(*1,*2,*4 I/O)				
I _{CC4}	Operating Current (PP)	CS#=VCC			1.4	mA
I _{CC5}	Operating Current (WRSR)	CS#=VCC			1.4	mA
Icc6	Operating Current (SE)	CS#=VCC			1.3	mA
I _{CC7}	Operating Current (BE)	CS#=VCC			1.3	mA
I _{CC8}	Operating Current (CE)	CS#=VCC			1.5	mA
VIL	Input Low Voltage				0.2VCC	V
VIH	Input High Voltage		0.7VCC			V
V _{OL}	Output Low Voltage	I _{OL} =100μA			0.2	V
V _{он}	Output High Voltage	I _{OH} =-100µА	VCC-0.2			V

Note:

1. Typical values given for TA=25°C.

2. Value guaranteed by design and/or characterization, not 100% tested in production.

(T= -40°C~105°C, VCC=1.65~3.6V)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit.
lu	Input Leakage Current				±2	μΑ
Ilo	Output Leakage Current				±2	μΑ
Icc1	Standby Current	CS#=VCC,		10		μΑ
		V _{IN} =VCC or VSS				
I _{CC2}	Deep Power-Down Current	CS#=VCC,		0.65	30	μΑ
		V _{IN} =VCC or VSS				
		CLK=0.1VCC /				
		0.9VCC				
		at 104MHz,		2.5	4.2	mA
		Q=Open(*1,*2,*4 I/O)				
Іссз	Operating Current (OB Read)	CLK=0.1VCC /				
		0.9VCC				
		at 80MHz,		2.1	3.6	mA
		Q=Open(*1,*2,*4 I/O)				
Icc4	Operating Current (PP)	CS#=VCC			1.5	mA
Icc5	Operating Current (WRSR)	CS#=VCC			1.5	mA
Icc6	Operating Current (SE)	CS#=VCC			1.4	mA
Icc7	Operating Current (BE)	CS#=VCC			1.4	mA
Icc8	Operating Current (CE)	CS#=VCC			1.6	mA
VIL	Input Low Voltage				0.2VCC	V
VIH	Input High Voltage		0.7VCC			V
Vol	Output Low Voltage	Ιοι=100μΑ			0.2	V
Vон	Output High Voltage	Іон =-100μА	VCC-0.2			V

Note:

1. Typical values given for TA=25°C.

Value guaranteed by design and/or characterization, not 100% tested in production

8.6. AC CHARACTERISTICS

(T= -40°C~85°C, VCC=1.65~3.6V, C_L=30pf)

C	Deservation	1.6	5V~2	.3V	2.	3V~2.	7V	2.7V~3.6V			
Symbol	Parameter	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
Fc	Serial Clock Frequency For: Dual I/O(BBH), Quad I/O (EBH), Quad Output (6BH)			60			90			104	MHz
f _{RO}	Serial Clock Frequency For: Read ID (90H, 9FH and ABH), Read Status Register (05H and 35H)			60			90			104	MHz
f _{R1}	Serial Clock Frequency For: Read (03H)			40			55			80	MHz
tсьн	Serial Clock High Time	8			5			4			ns
tcll	Serial Clock Low Time	8			5			4			ns
tсьсн	Serial Clock Rise Time (Slew Rate)	0.1			0.1			0.1			V/ns
tchcl	Serial Clock Fall Time (Slew Rate)	0.1			0.1			0.1			V/n
tslch	CS# Active Setup Time	10			5			5			ns
tснян	CS# Active Hold Time	10			5			5			ns
tsнсн	CS# Not Active Setup Time	5			5			5			ns
tchsl	CS# Not Active Hold Time	5			5			5			ns
t _{shsl}	CS# High Time (Read/Write)	20			20			20			ns
tsнqz	Output Disable Time			6			6			6	ns
tclax	Output Hold Time	1.2			1.2			1.2			ns
t _{DVCH}	Data In Setup Time	3			2	A.		2			ns
tchdx	Data In Hold Time	3			2			2			ns
tньсн	HOLD# Low Setup Time (Relative To Clock)	5			5			5			ns
t _{ннсн}	HOLD# High Setup Time (Relative To Clock)	5			5			5			ns
tchhl	HOLD# High Hold Time (Relative To Clock)	5			5			5			ns
tсннн	HOLD# Low Hold Time (Relative To Clock)	5			5			5			ns
thiqz	HOLD# Low To High-Z Output			6			6			6	ns
tннох	HOLD# High To Low-Z Output			6			6			6	ns
tclqv	Clock Low To Output Valid			7			7			7	ns
twhsl	Write Protect Setup Time Before CS# Low	20			20			20			ns
tshwl	Write Protect Hold Time After CS# High	100			100			100			ns
t _{DP}	CS# High To Deep Power-Down Mode			31			25			25	μs



t _{RES1}	CS# High To Standby Mode Without Electronic Signature Read		31		25		25	μs
t _{RES2}	CS# High To Standby Mode With Electronic Signature Read		31		25		25	μs
tsus	CS# High To Next Command After Suspend		26		20		20	μs
t _{RS}	Latency Between Resume And Next Suspend		16		10		10	μs
	CS# High To Next Command After Reset (Except From WRSR & Chip Erase)		36		30		30	μs
trst	CS# High To Next Command After Reset (From Chip Erase)		150		120		120	μs
	CS# High To Next Command After Reset (From WRSR)		4.5		4.5		4.5	ms
tw	Write Status Register Cycle Time	3.1	4.5	3.1	4.5	3.1	4.5	ms
t _{BP1}	Byte Program Time (First Byte)	68	95	68	95	68	95	us
t _{BP2}	Additional Byte Program Time (After First Byte)	9	13	9	13	9	13	us
t _{PP}	Page Programming Time	1.4	1.7	1.4	1.7	1.4	1.7	ms
t _{se}	Sector Erase Time (4K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
t _{BE1}	Block Erase Time (32K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
t _{BE2}	Block Erase Time (64K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
tce	Chip Erase Time (TH25Q-16UB)	5.2	7.8	5.2	7.8	5.2	7.8	ms

Note:

1. Typical values given for TA=25°C.

2. Value guaranteed by design and/or characterization, not 100% tested in production



(T= -40°C~105°C, VCC=1.65~3.6V, C_L=30pf)

Cumb al	Deventer	1.6	5V~2	.3V	2.3	3V~2.	7V	2.7V~3.6V			Unit
Symbol	Parameter	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
Fc	Serial Clock Frequency For: Dual I/O(BBH), Quad I/O (EBH), Quad Output (6BH)			60			90			104	МН
f _{R0}	Serial Clock Frequency For: Read ID (90H, 9FH and ABH), Read Status Register (05H and 35H)			60			90			104	МН
f _{R1}	Serial Clock Frequency For: Read (03H)			40			55			80	MH
tclh	Serial Clock High Time	8			5			4			ns
t _{CLL}	Serial Clock Low Time	8			5			4			ns
tсьсн	Serial Clock Rise Time (Slew Rate)	0.1			0.1			0.1			V/n
tchcl	Serial Clock Fall Time (Slew Rate)	0.1			0.1			0.1			V/n
tslch	CS# Active Setup Time	10			5			5			ns
tснsн	CS# Active Hold Time	10			5			5			ns
t _{sнсн}	CS# Not Active Setup Time	5			5			5			ns
tchsl	CS# Not Active Hold Time	5			5			5			ns
tshsl	CS# High Time (Read/Write)	20			20			20			ns
tsнqz	Output Disable Time			6			6			6	ns
tclax	Output Hold Time	1.2			1.2			1.2			ns
t _{DVCH}	Data In Setup Time	3			2			2			ns
tснdх	Data In Hold Time	3			2			2			ns
tньсн	HOLD# Low Setup Time (Relative To Clock)	5			5			5			ns
tннсн	HOLD# High Setup Time (Relative To Clock)	5			5			5			ns
tchhl	HOLD# High Hold Time (Relative To Clock)	5			5			5			ns
tсннн	HOLD# Low Hold Time (Relative To Clock)	5			5			5			ns
thlqz	HOLD# Low To High-Z Output			6			6			6	ns
tннох	HOLD# High To Low-Z Output			6			6			6	ns
tclqv	Clock Low To Output Valid			7			7			7	ns
twhsl	Write Protect Setup Time Before CS# Low	20			20			20			ns
tshwl	Write Protect Hold Time After CS# High	100			100			100			ns
tdp	CS# High To Deep Power-Down Mode			31			25			25	μs



t _{res1}	CS# High To Standby Mode Without Electronic Signature Read		31		25		25	μs
t _{RES2}	CS# High To Standby Mode With Electronic Signature		31		25		25	μs
tsus	CS# High To Next Command After Suspend		26		20		20	μs
t _{RS}	Latency Between Resume And Next Suspend		16		10		10	μs
	CS# High To Next Command After Reset (Except From WRSR & Chip Erase)		36		30		30	μs
trst	CS# High To Next Command After Reset (From Chip Erase)		150		120		120	μs
	CS# High To Next Command After Reset (From WRSR)		4.5		4.5		4.5	ms
tw	Write Status Register Cycle Time	3.1	4.5	3.1	4.5	3.1	4.5	ms
t _{BP1}	Byte Program Time (First Byte)	68	95	68	95	68	95	us
t _{BP2}	Additional Byte Program Time (After First Byte)	9	13	9	13	9	13	us
t _{PP}	Page Programming Time	1.4	1.7	1.4	1.7	1.4	1.7	ms
t _{SE}	Sector Erase Time (4K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
t _{BE1}	Block Erase Time (32K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
t _{BE2}	Block Erase Time (64K Bytes)	5.1	7.6	5.1	7.6	5.1	7.6	ms
tce	Chip Erase Time (TH25Q-16UB)	5.2	7.8	5.2	7.8	5.2	7.8	ms

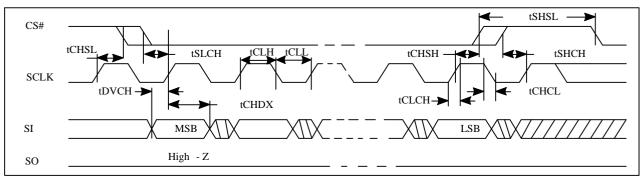
Note:

1. Typical values given for TA=25°C.

2. Value guaranteed by design and/or characterization, not 100% tested in production









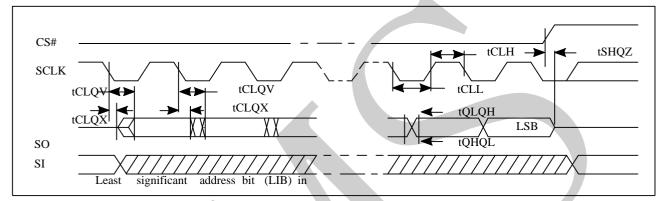
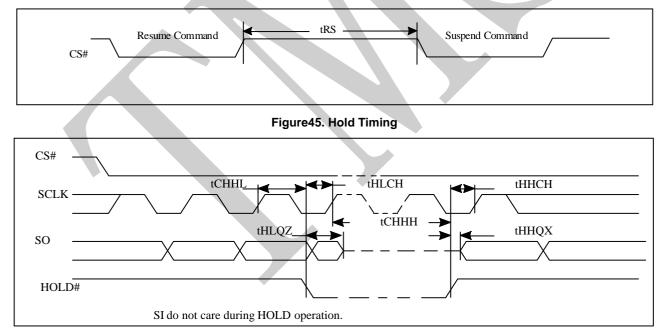


Figure 44. Resume to Suspend Timing Diagram



9. ORDERING INFORMATION

内 紫光青藤

	<u>TH 25Q - 16 U B - WFA I</u>
Company Designator	
TH=TsingHuaic	
Product serial	
25Q=SPI NOR	
Memory density	
20=2Mbit	
40=4Mbit	
80=8Mbit	
16=16Mbit	
Operation voltage	
U=1.65 [°] 3.6V	
L=1.65 ² .0V	
H=2. 7 [~] 3. 6V	
Generation	
A=A version	
B=B version	
Package type	
WFA=unsawn WAFER	
MSA=SOP8 150mil Tube	
MSB=SOP8 208mil Tube	
MSC=SOP8 150mil Reel	
MSD=SOP8 208mil Reel	
MTA=TSSOP8 Reel	
UXA=USON8 3x2mm Reel	
UXB=USON8 1.5x1.5mm Reel	
UXC=USON8 3x2mm Reel Wide Epad	
WXA=WSON8 6x5mm Tray	

Device Grade

 $I = -40^{\sim}85C$

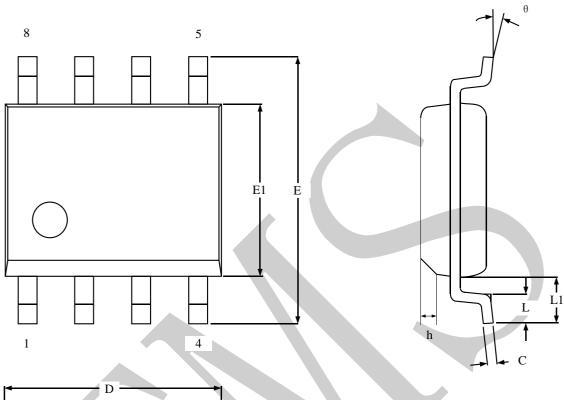
 $\text{K= }-40^{\sim}105\text{C}$

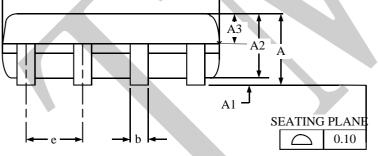
* Please contact TMS Device sales for automotive products.

10. PACKAGE INFORMATION

10.1. 8-Lead SOP(150mil)

D 紫光青藤





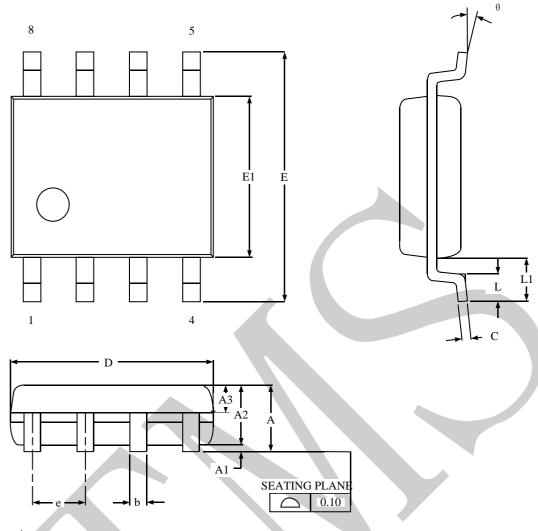
Dimensions

	1010110														
Symb	loc	А	A1	A2	A3	b	с	D	Е	E1	е		L1	h	θ
Unit		~		72	73	b	C	D	L	L 1	ט	L	L1		0
	Min	-	0.10	1.30	0.6	0.39	0.20	4.80	5.80	3.80		0.50		0.25	0
mm	Nom	-	-	1.40	0.65	-	-	4.90	5.90	3.90	1.27 BSC	-	1.05	-	-
	Max	1.75	0.225	1.50	0.7	0.47	0.24	5.00	6.20	4.00	200	0.80		0.50	8
	Min	-	0.004	0.051	0.024	0.015	0.008	0.189	0.228	0.150		0.020		0.010	0
Inch	Nom	-	-	0.055	0.026	-	-	0.193	0.236	0.154	0.050 BSC	-	0.041	-	-
	Max	0.069	0.009	0.059	0.028	0.019	0.009	0.197	0.244	0.158		0.031		0.020	8

TITLE	DRAWING NO.	REV	REF
8-Lead SOP(150mil)		A	JEDEC MS-012



10.2. 8-Lead SOP(208mil)



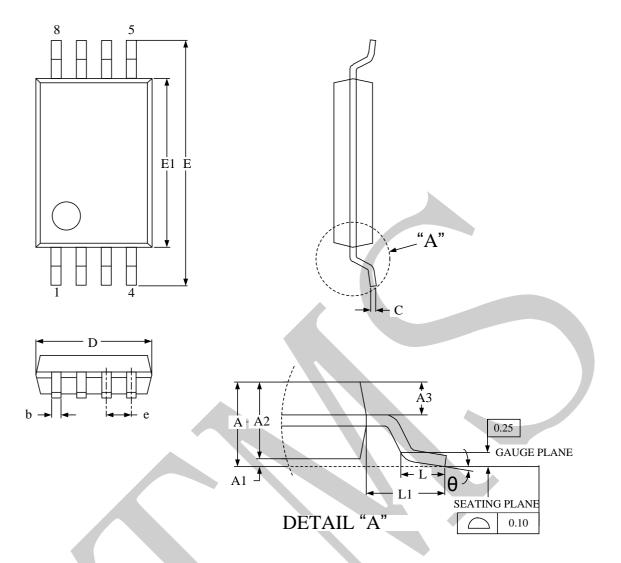
Dimensions

Symb	bol	А	A1	A2	A3	b	с	D	Е	E1	е		L1	θ
Unit		A	AI	AZ.	AJ	b	0		Ľ		e	L	LI	0
	Min	1.75	0.05	1.70	0.55	0.38		5.13	7.70	5.18		0.50	1.21	0
mm	Nom	1.9	0.1	1.80	0.60	0.43	0.203 REF	5.23	7.90	5.28	1.27 REF	0.65	1.31	-
	Max	2.05	0.15	1.90	0.65	0.48		5.33	8.10	5.38		0.80	1.41	8
	Min	0.069	0.002	0.067	0.022	0.015	0.000	0.202	0.303	0.204	0.050	0.020	0.048	0
Inch	Nom	0.075	0.004	0.071	0.024	0.017	0.008 REF	0.206	0.311	0.208	0.050 REF	0.026	0.052	-
	Max	0.081	0.006	0.075	0.026	0.019		0.210	0.319	0.212		0.031	0.056	8

TITLE	DRAWING NO.	REV	REF
8-Lead SOP(208mil)		A	



10.3. 8-Lead TSSOP(173mil)

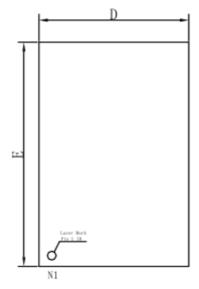


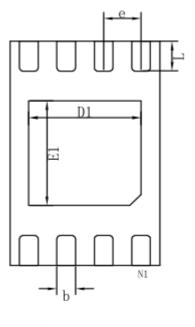
Dimen	sions													
Symbo	ol	^	A 1	A2	A3	h	с	D	-	E1		ı	1.4	θ
Unit		A	A1	AZ	AJ	b	U	D	E		е	L	L1	0
	Min	-	0.05	0.90	0.39	0.20	0.13	2.90	6.20	4.30		0.45		0
mm	Nom	-	-	1.00	0.44		-	3.00	6.40	4.40	0.65 BSC	-	1.00 REF	-
	Max	1.20	0.15	1.05	0.49	0.28	0.17	3.10	6.60	4.50	200	0.75		8
	Min	-	0.002	0.035	0.015	0.008	0.005	0.114	0.244	0.169	0.000	0.018	0.000	0
Inch	Nom	-	-	0.039	0.017	-	-	0.118	0.252	0.173	0.026 BSC	-	0.039 REF	-
	Max	0.047	0.006	0.041	0.019	0.011	0.007	0.122	0.260	0.177		0.030		8

TITLE	DRAWING NO.	REV	REF
8-lead TSSOP		A	JEDEC MO-153

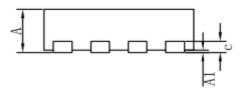


10.4. 8-Land USON(3x2mm)





bottom view



Dimensions

Symb	ol	А	A1	b	с	D	D1	Е	E1	е	
Unit		~		D	Ū	D	DI	L	L 1	e	L
	Min	0.50	0.00	0.20		1.90	1.40	2.90	1.30		0.30
mm	Nom	0.55	0.03	0.25		2.00	1.50	3.00	1.40		0.40
	Max	0.60	0.05	0.30	0.152REF	2.05	1.60	3.05	1.50	0.50TYP	0.50
	Min	0.020	0.00	0.008	0.1021(E)	0.075	0.055	0.114	0.051	0.00111	0.012
Inch	Nom	0.021		0.010		0.079	0.059	0.118	0.055		0.016
	Max	0.024	0.002	0.012		0.081	0.063	0.120	0.059		0.020

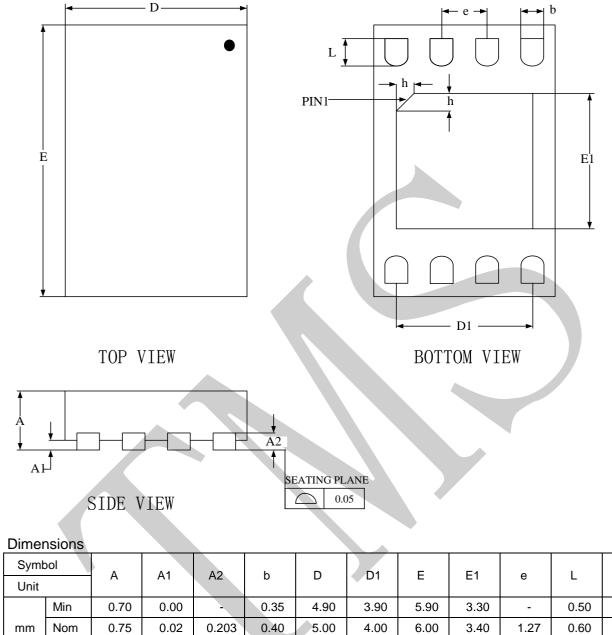
TITLE	DRAWING NO.	REV	REF
DFN8L(0203X0.55-0.5)		A	JEDEC MO-252

紫光青藤 TH25Q-16UB Datasheet

Т

8-Land WSON(6x5mm) 10.5.

阳



Symbol		А	A1	A2 b	h	D	D1	E	E1	е	L	h
Unit					D							
	Min	0.70	0.00	1	0.35	4.90	3.90	5.90	3.30	-	0.50	0.30
mm	Nom	0.75	0.02	0.203	0.40	5.00	4.00	6.00	3.40	1.27	0.60	0.35
	Max	0.80	0.05	-	0.48	5.10	4.10	6.10	3.50	-	0.75	0.40
	Min	0.028	0.000	-	0.014	0.193	0.154	0.232	0.129	-	0.020	0.033
Inch	Nom	0.030	-	0.008	0.016	0.197	0.157	0.236	0.134	0.05	0.024	0.039
	Max	0.032	0.002	-	0.019	0.201	0.161	0.240	0.138	-	0.030	0.045

TITLE	DRAWING NO.	REV	REF
DFN8 (0506X0.75-1.27)		A	JEDEC MO-220



11. REVISION HISTORY

Version No	Description	Page	Date
1.0	Initial Release	All	2021-11-10
1.1	Modify AC CHARACTERISTICS	50~53	2022-02-27
1.2	Update program & erase time in AC CHARACTERISTICS	51,53	2022-03-03
1.3	Update ID Definitions ID15-8 to 70	15	2022-03-18